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MEASUREMENT REPORT
FCC PART 15.247 Bluetooth

Applicant Name:
Samsung Electronics, Co. Ltd.
129, Samsung-ro, Maetan dong,
Yeongtong-gu, Suwon-si
Gyeonggi-do 443-742, Korea

Date of Testing:
Dec 23, 2013 - Jan 31, 2014
Test Site/Location:
PCTEST Lab. Columbia, MD, USA
Test Report Serial No.:
0Y1312182466.A3L

FCC ID:	**A3LSMW750V**
APPLICANT:	**Samsung Electronics, Co. Ltd.**

Application Type:	Certification
Model(s):	SM-W750V
EUT Type:	Portable Handset
Max. RF Output Power:	11.937 mW (10.77dBm) Conducted
Frequency Range:	2402 – 2480MHz (Bluetooth for US)
Type of Modulation:	GFSK, π/4-DQPSK, 8DPSK
FCC Classification:	FCC Part 15 Spread Spectrum Transmitter (DSS)
FCC Rule Part(s):	Part 15 Subpart C (15.247)
Test Procedure(s):	DA 00-705

This equipment has been shown to be capable of compliance with the applicable technical standards as indicated in the measurement report and was tested in accordance with the measurement procedures specified in DA 00-705. Test results reported herein relate only to the item(s) tested.

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.

Randy Ortanez
President

ACCREDITED
TESTING LABORATORY
CERTIFICATE #2041.01

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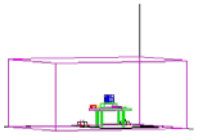
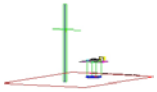


MEASUREMENT REPORT
FCC Part 15.247



§ 2.1033 General Information

APPLICANT:	Samsung Electronics, Co. Ltd.
APPLICANT ADDRESS:	129, Samsung-ro, Maetan dong, Yeongtong-gu, Suwon-si, Gyeonggi-do 443-742, Korea
TEST SITE:	PCTEST ENGINEERING LABORATORY, INC.
TEST SITE ADDRESS:	6660-B Dobbin Road, Columbia, MD 21045 USA
FCC RULE PART(S):	Part 15 Subpart C (15.247)
IC SPECIFICATION(S):	RSS-210 Issue 8
BASE MODEL:	SM-W750V
FCC ID:	A3LSMW750V
Test Device Serial No.:	#9 & #10 ☐ Production ☒ Pre-Production ☐ Engineering
FCC CLASSIFICATION:	FCC Part 15 Spread Spectrum Transmitter (DSS)
Method/System:	Frequency Hopping Spread Spectrum (FHSS)
DATE(S) OF TEST:	Dec 23, 2013 - Jan 31, 2014
TEST REPORT S/N:	0Y1312182466.A3L

Test Facility / Accreditations

Measurements were performed at PCTEST Engineering Lab located in Columbia, MD 21045, U.S.A.

- PCTEST facility is an FCC registered (PCTEST Reg. No. 90864) test facility with the site description report on file and has met all the requirements specified in Section 2.948 of the FCC Rules and Industry Canada (2451A-1).
- PCTEST Lab is accredited to ISO 17025 by U.S. National Institute of Standards and Technology (NIST) under the National Voluntary Laboratory Accreditation Program (NVLAP Lab code: 100431-0) in EMC, FCC and Telecommunications.
- PCTEST Lab is accredited to ISO 17025-2005 by the American Association for Laboratory Accreditation (A2LA) in Specific Absorption Rate (SAR) testing, Hearing Aid Compatibility (HAC) testing, CTIA Test Plans, and wireless testing for FCC and Industry Canada Rules.
- PCTEST Lab is a recognized U.S. Conformity Assessment Body (CAB) in EMC and R&TTE (n.b. 0982) under the U.S.-EU Mutual Recognition Agreement (MRA).
- PCTEST TCB is a Telecommunication Certification Body (TCB) accredited to ISO/IEC Guide 65 by the American National Standards Institute (ANSI) in all scopes of FCC Rules and Industry Canada Standards (RSS).
- PCTEST facility is an IC registered (2451A-1) test laboratory with the site description on file at Industry Canada.
- PCTEST is a CTIA Authorized Test Laboratory (CATL) for AMPS, CDMA, and EvDO wireless devices and for Over-the-Air (OTA) Antenna Performance testing for AMPS, CDMA, GSM, GPRS, EGPRS, UMTS (W-CDMA), CDMA 1xEVDO, and CDMA 1xRTT.

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1.0 INTRODUCTION

1.1 Scope

Measurement and determination of electromagnetic emissions (EMC) of radio frequency devices including intentional and/or unintentional radiators for compliance with the technical rules and regulations of the Federal Communications Commission and the Industry Canada Certification and Engineering Bureau.

1.2 PCTEST Test Location

The map below shows the location of the PCTEST LABORATORY, its proximity to the FCC Laboratory, the Columbia vicinity, the Baltimore-Washington Internt'l (BWI) airport, the city of Baltimore and the Washington, DC area. (*See Figure 1-1*).

Testing was conducted at PCTEST Engineering Laboratory, Inc. facility located in New Concept Business Park, Columbia, Maryland. The site address is 6660-B Dobbin Road, Columbia, MD 21045. The test site is one of the highest points in the Columbia area with an elevation of 390 feet above mean sea level. The site coordinates are 39° 11'15" N latitude and 76° 49'38" W longitude. The facility is 1.5 miles North of the FCC laboratory, and the ambient signal and ambient signal strength are approximately equal to those of the FCC laboratory. There are no FM or TV transmitters within 15 miles of the site. The detailed description of the measurement facility was found to be in compliance with the requirements of § 2.948 according to ANSI C63.4-2009 on January 10, 2012.

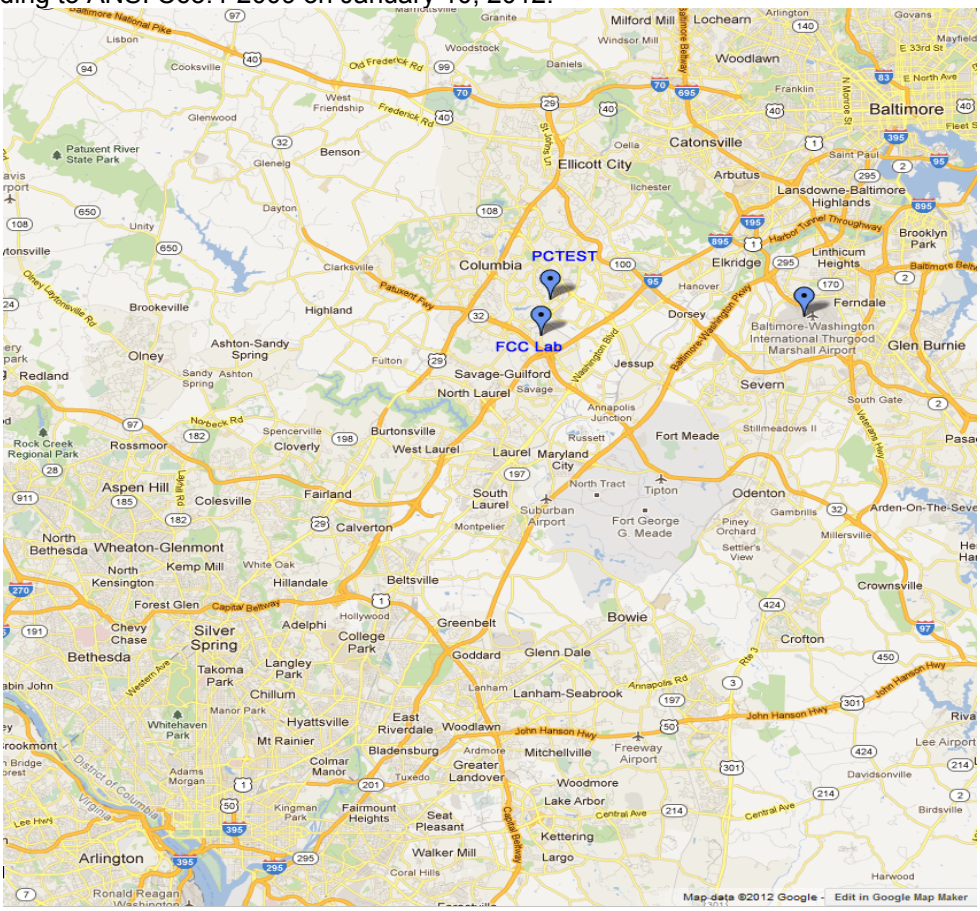

Figure 1-1. Map of the Greater Baltimore and Metropolitan Washington, D.C. area

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2.0 PRODUCT INFORMATION

2.1 Equipment Description

The Equipment Under Test (EUT) is the **Samsung Portable Handset FCC ID: A3LSMW750V**. The test data contained in this report pertains only to the emissions due to the EUT's Bluetooth transmitter.

- This Bluetooth module has been tested by a Bluetooth Qualification Lab, and we confirm the following:
  - A) The hopping sequence is pseudorandom
  - B) All channels are used equally on average
  - C) The receiver input bandwidth equals the transmit bandwidth
  - D) The receiver hops in sequence with the transmit signal
- 15.247(g): In accordance with the Bluetooth Industry Standard, the system is designed to comply with all of the regulations in Section 15.247 when the transmitter is presented with a continuous data (or information) system.
- 15.247(h): In accordance with the Bluetooth Industry Standard, the system does not coordinate its channels selection/ hopping sequence with other frequency hopping systems for the express purpose of avoiding the simultaneous occupancy of individual hopping frequencies by multiple transmitters.
- 15.247(h): The EUT employs Adaptive Frequency Hopping (AFH) which identifies sources of interference namely devices operating in 802.11 WLAN and excludes them from the list of available channels. The process of re-mapping reduces the number of test channels from 79 channels to a minimum number of 20 channels.

2.2 Device Capabilities

This device contains the following capabilities:

850/1900 CDMA/EvDO Rev0/A (BC0, BC1), 850/1900 GSM/GPRS/EDGE, 850/1900 WCDMA/HSPA, LTE (Band 4 and 13), 802.11a/b/g/n/ac WLAN (DTS/NII), Bluetooth (1x,EDR), NFC

2.3 Test Configuration

The Samsung Portable Handset FCC ID: A3LSMW750V was tested per the guidance of DA 00-705. See Sections 3.2, 3.3, and 6.1 of this test report for a description of the AC line conducted emissions, radiated emissions, and antenna port conducted emissions test setups, respectively.

2.4 EMI Suppression Device(s)/Modifications

No EMI suppression device(s) were added and no modifications were made during testing.

2.5 Labeling Requirements

Per 15.19; Docket 95-19

The label shall be permanently affixed at a conspicuous location on the device; instruction manual or pamphlet supplied to the user and be readily visible to the purchaser at the time of purchase. However, when the device is so small wherein placement of the label with specified statement is not practical, only the trade name and FCC ID must be displayed on the device per Section 15.19(a)(5). Please see attachment for FCC ID label and label location.

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3.0 DESCRIPTION OF TEST

3.1 Evaluation Procedure

The measurement procedure described in the "Filing and Measurement Guidelines for Frequency Hopping Spread Spectrum Systems" (DA 00-705) were used in the measurement of the **Samsung Portable Handset FCC ID: A3LSMW750V.**

Deviation from measurement procedure…….....None

3.2 AC Line Conducted Emissions

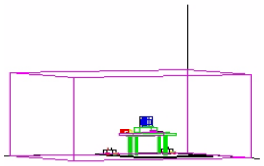

Figure 3-1. Shielded Enclosure Line-Conducted Test Facility

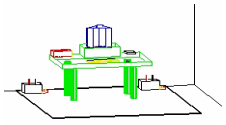

Figure 3-2. Line Conducted Emission Test Set-Up

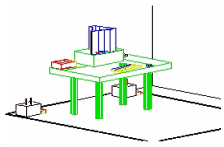

Figure 3-3. Wooden Table & Bonded LISNs

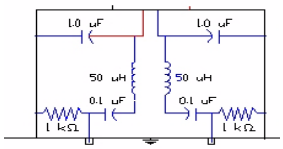

Figure 3-4. LISN Schematic Diagram

The line-conducted facility is located inside a 16'x20'x10' shielded enclosure, manufactured by Ray Proof Series 81 (*see Figure 3-1*). The shielding effectiveness of the shielded room is in accordance with MIL-Std-285 or NSA 65-5. A 1m x 1.5m wooden table 80cm high is placed 40cm away from the vertical wall and 1.5m away from the sidewall of the shielded room (*see Figure 3-2*). Two 10kHz-30MHz, 50Ω/50μH Line-Impedance Stabilization Networks (LISNs) are bonded to the shielded room (*see Figure 3-3).* Power to the LISNs are filtered by a high-current high-insertion loss Ray Proof power line filter (100dB 14Hz-10GHz). The purpose of the filter is to attenuate ambient signal interference and this filter is also bonded to the shielded enclosure. All electrical cables are shielded by braided tinned copper zipper tubing with an inner diameter of ½".

The EUT is powered from one LISN and the support equipment is powered from the second LISN. If the EUT is a DC-powered device, power will be derived from the source power supply it normally will be powered from and this supply line(s) will be connected to the Solar LISN. The LISN schematic diagram is shown (*see Figure 3-4*). All interconnecting cables more than 1 meter were shortened to a 1 meter length by non-inductive bundling (serpentine fashion) and draped over the back edge of the test table. All cables were at least 40cm above the horizontal reference groundplane. Power cables for support equipment were routed down to the second LISN while ensuring that that cables were not draped over the second LISN.

Sufficient time for the EUT, support equipment, and test equipment was allowed in order for them to warm up to their normal operating condition. The RF output of the LISN was connected to the spectrum analyzer and exploratory measurements were made to determine the frequencies producing the maximum emission from the EUT. The spectrum was scanned from 150kHz to 30MHz with a spectrum analyzer. The detector function was set to peak mode for exploratory measurements. The bandwidth of the analyzer was set to 10kHz. The EUT, support equipment, and interconnecting cables were arranged and manipulated to maximize each emission emission. Each emission was maximized by varying: power lines, the mode of operation or resolution, clock or data exchange speed, scrolling H pattern to the EUT and/or support equipment, and powering the monitor from the floor mounted outlet box and the computer aux AC outlet, if applicable; whichever determined the worst-case emission. Once the worst case emissions have been identified, the one EUT cable configuration/arrangement and mode of operation that produced these emissions is used for final measurements on the same test site. The analyzer is set to CISPR quasi-peak and average detectors with a 9kHz bandwidth for final measurements. Each emission reported was calibrated using a signal generator.

Line conducted emissions test results are shown in Section 6.11. Automated test software was used to perform the AC line conducted emissions testing. Automated measurement software utilized is the PCTEST Conduction Automatic Measurement, Version 2.7.

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3.3 Radiated Emissions

The radiated test facilities consisted of an indoor semi-anechoic chamber used for exploratory measurements and an open area test site (OATS) used for final measurements. For all measurements, the spectrum was scanned through all EUT azimuths and from 1 to 4 meter receive antenna height using a broadband antenna from 30MHz up to the upper frequency shown in 15.33(b)(1) depending on the highest frequency generated or used in the device or on which the device operates or tunes. For frequencies higher than the upper frequency range of the broadband antenna used for testing, linearly polarized double ridge horn antennas were used. For frequencies below 30MHz, a calibrated loop antenna was used.

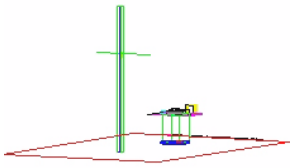

Figure 3-5. 3-Meter Test Site

Exploratory measurements were performed at 1 meter test distance inside the semi-anechoic chamber using broadband antennas, broadband amplifiers, and spectrum analyzers to determine the frequencies producing the maximum emissions. Sufficient time for the EUT, support equipment, and test equipment was allowed in order for them to warm up to their normal operating condition. The test set-up was placed on top of a 0.8 meter high non-metallic 1 x 1.5 meter table (*see Figure 3-7*). The EUT, support equipment, and interconnecting cables were arranged and manipulated to maximize each emission. Appropriate precaution was taken to ensure that all emissions from the EUT were maximized and investigated. The system configuration, clock speed, mode of operation or video resolution, turntable azimuth, and receive antenna height was noted for each frequency found. To record the exploratory measurements, the analyzers' detector function was set to peak mode and the bandwidth was set to 100kHz.

Figure 3-6. Dimensions of Outdoor Test Site

Final measurements were made on the OATS at 3 meter test range using calibrated, linearly polarized broadband or horn antennas (*see Figure 3-5*). The measurement area is situated on an 18 meter x 20 meter galvanized 1/2" hardware cloth as the conducting ground plane. This material is sewn together in sections 4 feet wide and 60 feet long. A total of eighteen sections are required to cover the entire measurement area. Sections are laid across the width of the pad, overlapped 1" and sewn and soldered together at intervals of 3" (7.6 cm.) The terrain of the test site is reasonably flat and level. Power and cable to the test site are buried 18" deep into the ground outside the perimeter of the site. An all-weather non-metallic housing is situated on a 2 x 3 meter area adjacent to the measurement area to house the test equipment (*see Figure 3-6*). The test set-up was again placed on top of the same a 0.8 meter high non-metallic 1 x 1.5 meter table on the OATS as used for exploratory measurements in the indoor chamber. The test set-up was re-configured to the same setup that was previously determined through exploratory measurements to have produced the worst case emissions. The spectrum analyzer was set to the frequencies found to have caused the highest radiated disturbances with respect to the limit during preliminary radiated measurements. The turntable containing the system was rotated through 360 degrees and the height of the receive antenna was varied 1 to 4 meters and stopped at the azimuth and height producing the maximum emission. Each emission was maximized by changing the orientation of the EUT through three orthogonal planes and changing the polarity of the receive antenna, whichever produced the worst-case emissions. For the EUT positioning, "H" is defined with the EUT lying flat on the test surface, "H2" is defined with the EUT standing up on its side, and "V" is defined with the EUT standing upright.

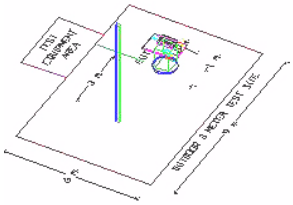

Figure 3-7. Turntable and System Setup

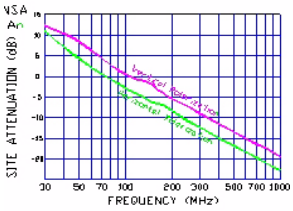

Figure 3-8. Normalized Site Attenuation Curves (H&V)

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4.0 ANTENNA REQUIREMENTS

Excerpt from §15.203 of the FCC Rules/Regulations:
"An intentional radiator antenna shall be designed to ensure that no antenna other than that furnished by the responsible party can be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator shall be considered sufficient to comply with the provisions of this section."

- The antennas of the Samsung Portable Handset are **permanently attached.**
- There are no provisions for connection to an external antenna.

Conclusion:

The **Samsung Portable Handset FCC ID: A3LSMW750V** unit complies with the requirement of §15.203.

Ch.	Frequency (MHz)
00	2402
:	:
39	2441
:	:
78	2480

Table 4-1. Frequency/ Channel Operations

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5.0 TEST EQUIPMENT CALIBRATION DATA

Test Equipment Calibration is traceable to the National Institute of Standards and Technology (NIST).

Manufacturer	Model	Description	Cal Date	Cal Interval	Cal Due	Serial Number
-	BT1	Bluetooth Cable Set	1/17/2013	Annual	1/17/2014	N/A
-	RE1	Radiated Emissions Cable Set (UHF/EHF)	3/29/2013	Annual	3/29/2014	N/A
Agilent	8447D	Broadband Amplifier	5/31/2013	Annual	5/31/2014	1937A03348
Agilent	8449B	(1-26.5GHz) Pre-Amplifier	4/17/2013	Annual	4/17/2014	3008A00985
Agilent	85650A	Quasi-Peak Adapter	4/17/2013	Annual	4/17/2014	2043A00301
Agilent	8566B	(100Hz-22GHz) Spectrum Analyzer	4/17/2013	Annual	4/17/2014	3638A08713
Agilent	N9020A	MXA Signal Analyzer	10/29/2013	Annual	10/29/2014	US46470561
Agilent	N4010A	Wireless Connectivity Test Set	N/A		N/A	GB46170464
Agilent	N9038A	MXE EMI Receiver	1/3/2014	Annual	1/3/2015	MY51210133
Anritsu	ML2495A	Power Meter	10/31/2013	Annual	10/31/2014	941001
Anritsu	MA2411B	Pulse Sensor	11/13/2013	Annual	11/13/2014	846215
Com-Power	AL-130	9kHz - 30MHz Loop Antenna	6/26/2013	Annual	6/26/2014	121034
Emco	3115	Horn Antenna (1-18GHz)	1/12/2012	Biennial	1/12/2014	9704-5182
Emco	3116	Horn Antenna (18 - 40GHz)	1/20/2012	Triennial	1/20/2015	9203-2178
Emco	6502	Active Loop Antenna (10k - 30 MHz)	5/31/2012	Biennial	5/31/2014	267
Emco	3816/2	Line Impedance Stabilization Network	2/12/2013	Biennial	2/12/2015	9709-1077
Emco	3816/2	Line Impedance Stabilization Network	2/12/2013	Biennial	2/12/2015	9707-1079
Mini-Circuits	VHF-3100+	High Pass Filter	1/21/2013	Annual	1/21/2014	31144
Rohde & Schwarz	CMU200	Base Station Simulator	5/3/2013	Annual	5/3/2014	836371/0079
Solar Electronics	8012-50-R-24-BNC	Line Impedance Stabilization Network	6/20/2013	Biennial	6/20/2015	310233
Sunol	DRH-118	Horn Antenna (1 - 18GHz)	6/19/2013	Biennial	6/19/2015	A050307
Sunol	JB5	Bi-Log Antenna (30M - 5GHz)	1/26/2012	Biennial	1/26/2014	A051107

Table 5-1. Annual Test Equipment Calibration Schedule

Note:

1. For equipment listed above that has a calibration due date that falls within the test date range, care was taken to ensure that this equipment was utilized prior to the calibration due date.

2. Equipment used for signaling with a calibration date of "N/A" shown in this list was only used for maintaining a link between the piece of equipment and the EUT. This equipment was not used to make direct calibrated measurements.

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6.0 TEST RESULTS

6.1 Summary

Company Name: Samsung Electronics, Co. Ltd.

FCC ID: A3LSMW750V

Method/System: Frequency Hopping Spread Spectrum (FHSS)

Number of Channels: 79

FCC Part Section(s)	RSS Section(s)	Test Description	Test Limit	Test Condition	Test Result	Reference
TRANSMITTER MODE (Tx)						
15.247(a)(1)(iii)	RSS-210 [A8.1]	20dB Bandwidth	< 1 MHz only if using less than 15 non-overlapping channels	CONDUCTED	PASS	Section 6.2
15.247(b)(1)	RSS-210 [A8.4(2)]	Peak Transmitter Output Power	< 1 Watt if ≥ 75 non-overlapping channels used		PASS	Section 6.3
15.247(a)(1)	RSS-210 [A8.1(2)]	Channel Separation	> 2/3 of 20 dB BW for systems with Output Power < 125mW		PASS	Section 6.5
15.247(a)(1)(iii)	RSS-210 [A8.1(4)]	Number of Channels	> 15 Channels		PASS	Section 6.7
15.247(a)(1)(iii)	RSS-210 [A8.1(4)]	Time of Occupancy	< 0.4 sec in 31.6 sec period		PASS	Section 6.6
15.247(d)	RSS-210 [A8.5]	Band Edge / Out-of-Band Emissions	Conducted > 20dBc		PASS	Section 6.4, Section 6.8
15.205 15.209	RSS-210 [A8.5]	General Field Strength Limits (Restricted Bands and Radiated Emission Limits)	Emissions in restricted bands must meet the radiated limits detailed in 15.209 (RSS-210 table 3 limits)	RADIATED	PASS	Section 6.9, Section 6.10
15.207	RSS-Gen [7.2.2]	AC Conducted Emissions 150kHz – 30MHz	< FCC 15.207 limits or < RSS-Gen table 2 limits	LINE CONDUCTED	PASS	Section 6.11

Table 6-1. Summary of Test Results

Notes:

1) All modes of operation and data rates were investigated. The test results shown in the following sections represent the worst case emissions.
2) The analyzer plots shown in this section were all taken with a correction table loaded into the analyzer. The correction table was used to account for the losses of the cables, directional couplers, and attenuators used as part of the system to maintain a link between the call box and the EUT at all frequencies of interest.
3) All antenna port conducted emissions testing was performed on a test bench with the antenna port of the EUT connected to the spectrum analyzer through calibrated cables, attenuators, and couplers.
4) For conducted spurious emissions, automated test software was used to measure emissions and capture the corresponding plots necessary to show compliance. The measurement software utilized is PCTEST "BT Auto", Version 2.0.

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6.2 20dB Bandwidth Measurement

§15.247 (a)(1)(iii); RSS-210 (A8.1)

The bandwidth at 20dB down from the highest in-band spectral density is measured with a spectrum analyzer connected to the receive antenna while the EUT is operating in transmission mode at the appropriate frequencies. ***The maximum permissible 20dB bandwidth is 1 MHz, unless more than 15 non-overlapping channels are employed.***

Frequency [MHz]	Data Rate [Mbps]	Channel No.	20dB Bandwidth Test Results	
			[kHz]	Pass/Fail
2402	1.0	0	952.9	Pass
2441	1.0	39	1003	Pass
2480	1.0	78	949.4	Pass
2402	2.0	0	1286	Pass
2441	2.0	39	1276	Pass
2480	2.0	78	1282	Pass
2402	3.0	0	1288	Pass
2441	3.0	39	1284	Pass
2480	3.0	78	1272	Pass

Table 6-2. Conducted 20dB Bandwidth Measurements

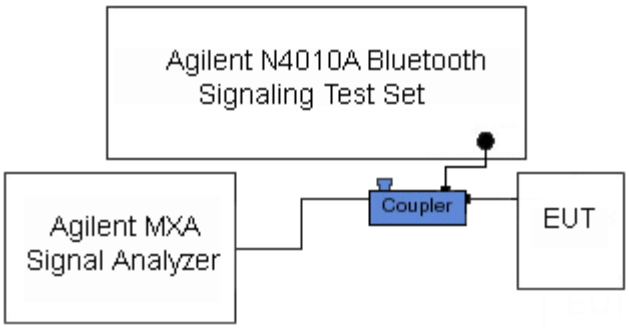

Figure 6-1. Test Instrument & Measurement Setup

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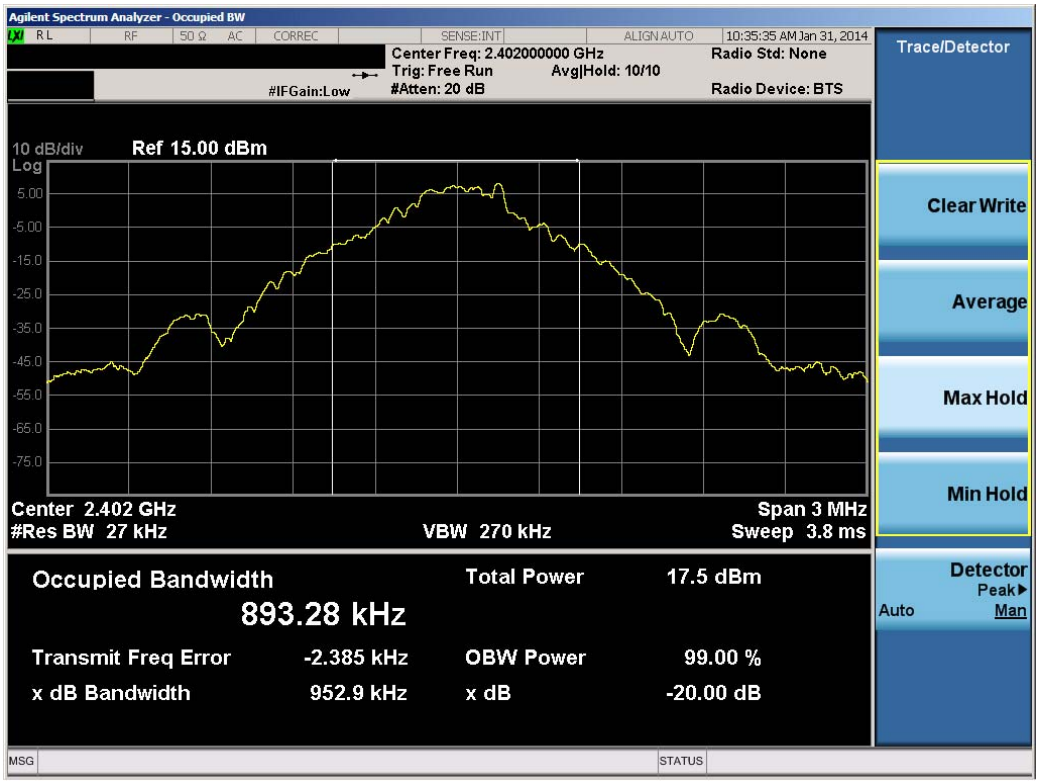
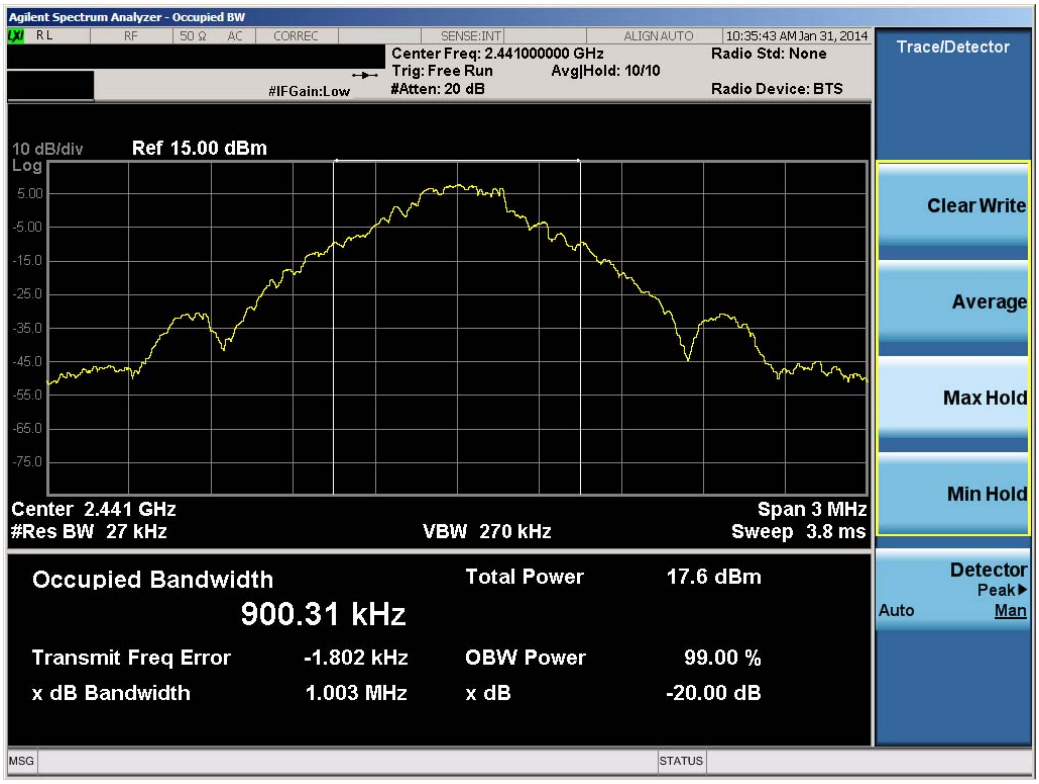


Plot 6-1. 20dB Bandwidth Plot (Bluetooth, 1Mbps – Ch. 0)



Plot 6-2. 20dB Bandwidth Plot (Bluetooth, 1Mbps – Ch. 39)

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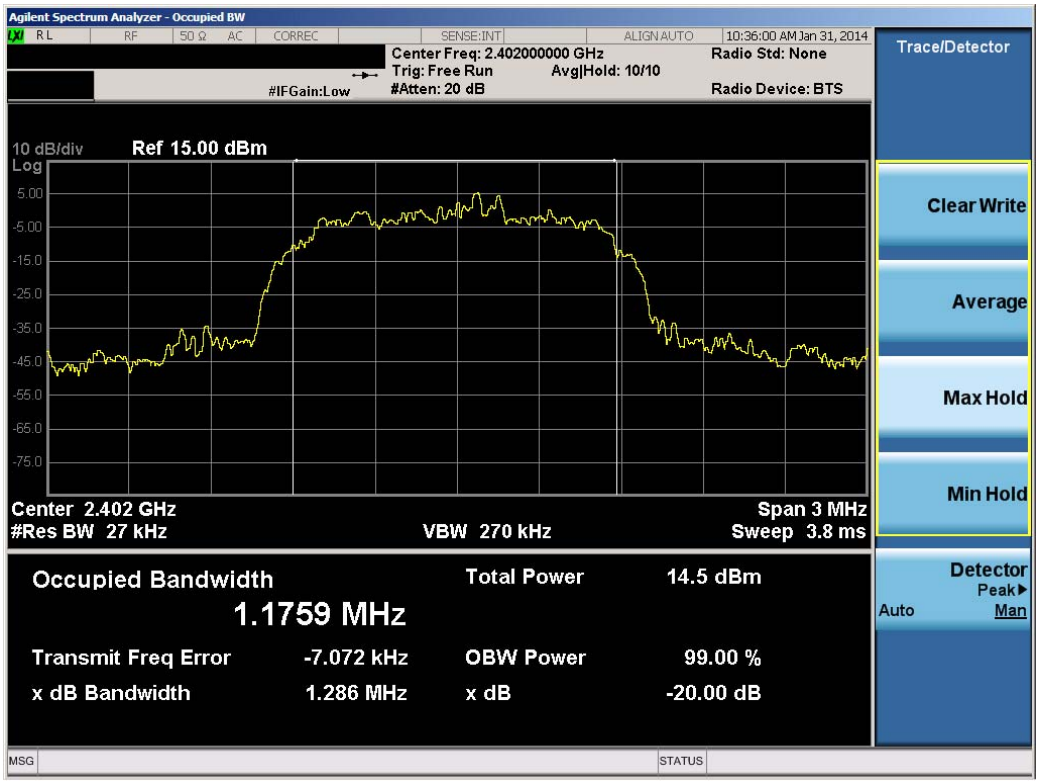
Plot 6-3. 20dB Bandwidth Plot (Bluetooth, 1Mbps – Ch. 78)



Plot 6-4. 20dB Bandwidth Plot (Bluetooth, 2Mbps – Ch. 0)

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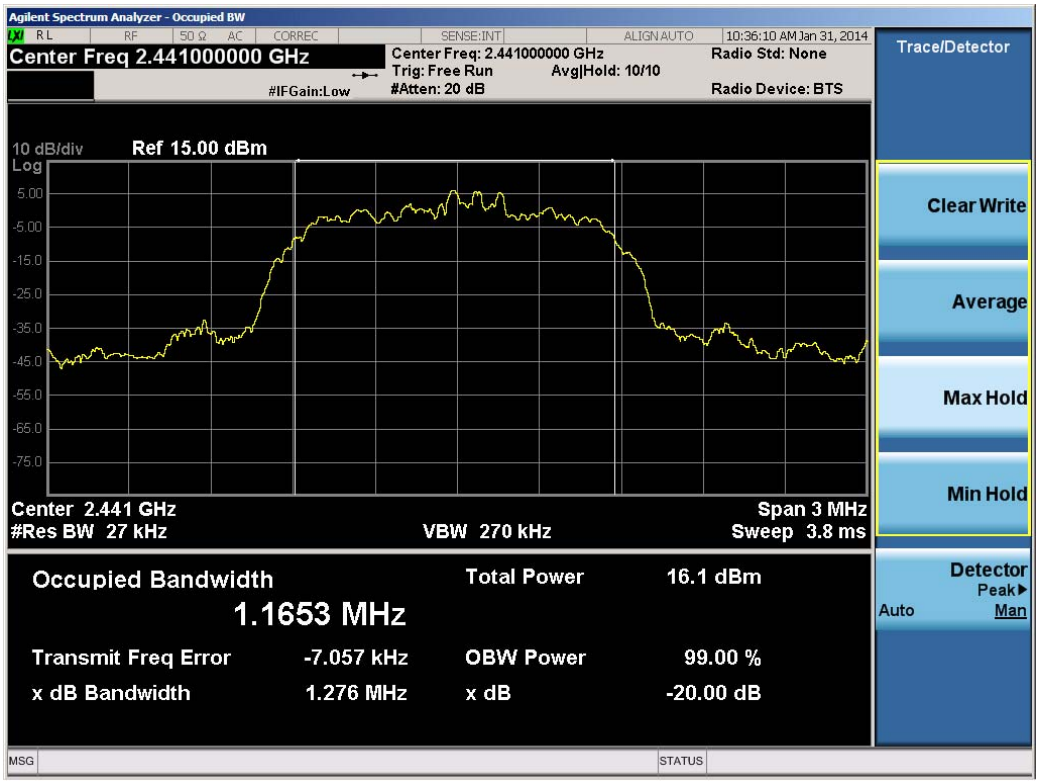
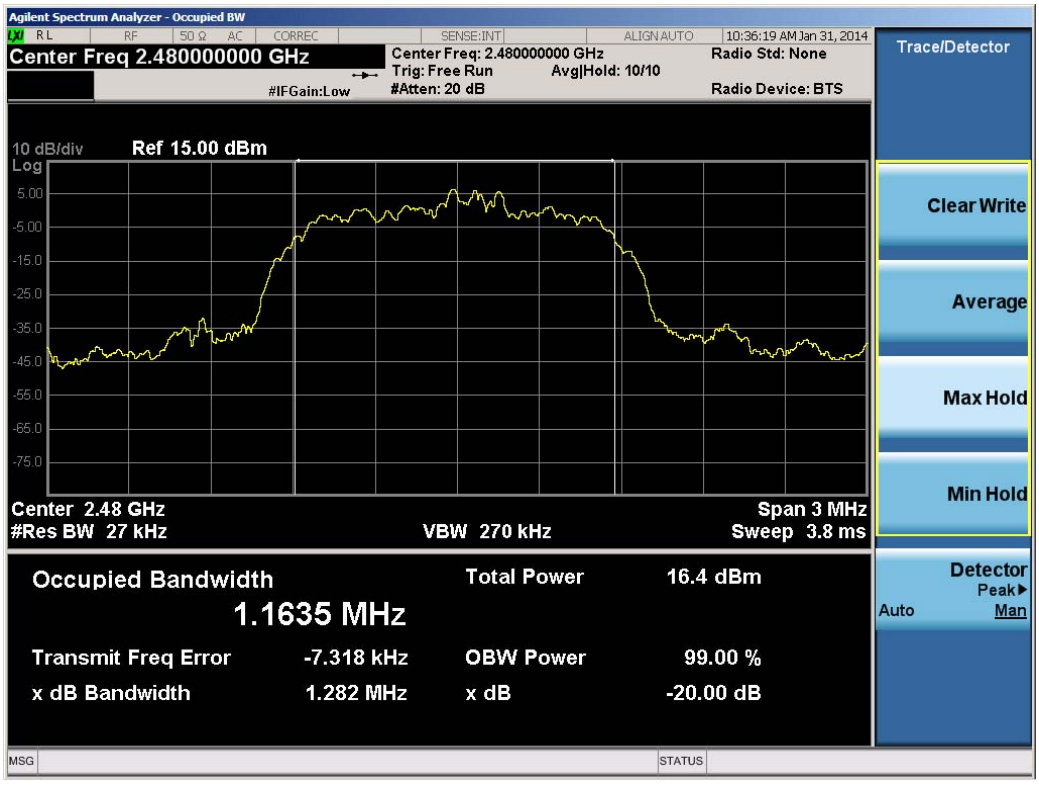


Plot 6-5. 20dB Bandwidth Plot (Bluetooth, 2Mbps – Ch. 39)



Plot 6-6. 20dB Bandwidth Plot (Bluetooth, 2Mbps – Ch. 78)

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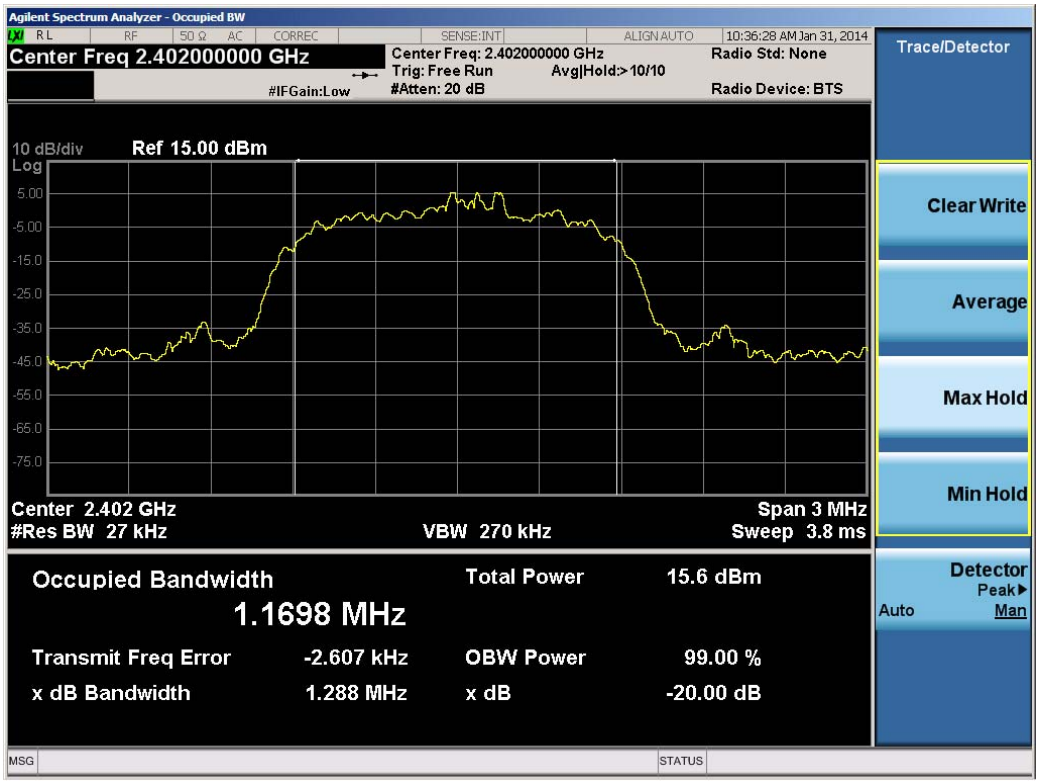
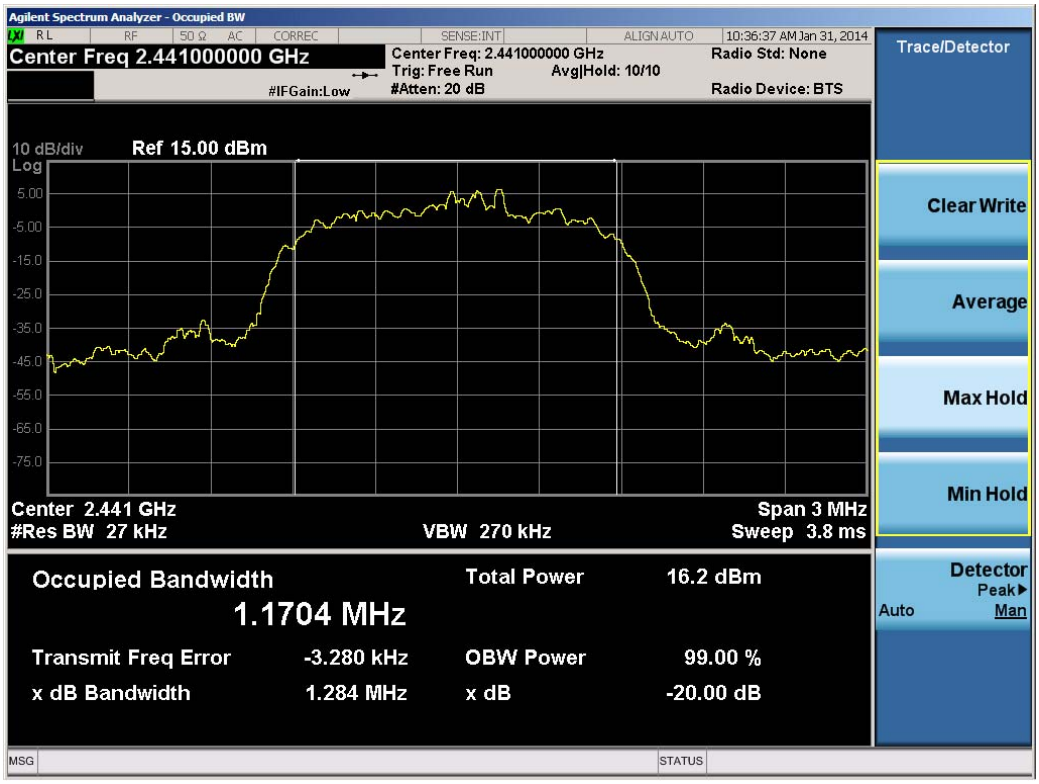


Plot 6-7. 20dB Bandwidth Plot (Bluetooth, 3Mbps – Ch. 0)



Plot 6-8. 20dB Bandwidth Plot (Bluetooth, 3Mbps – Ch. 39)

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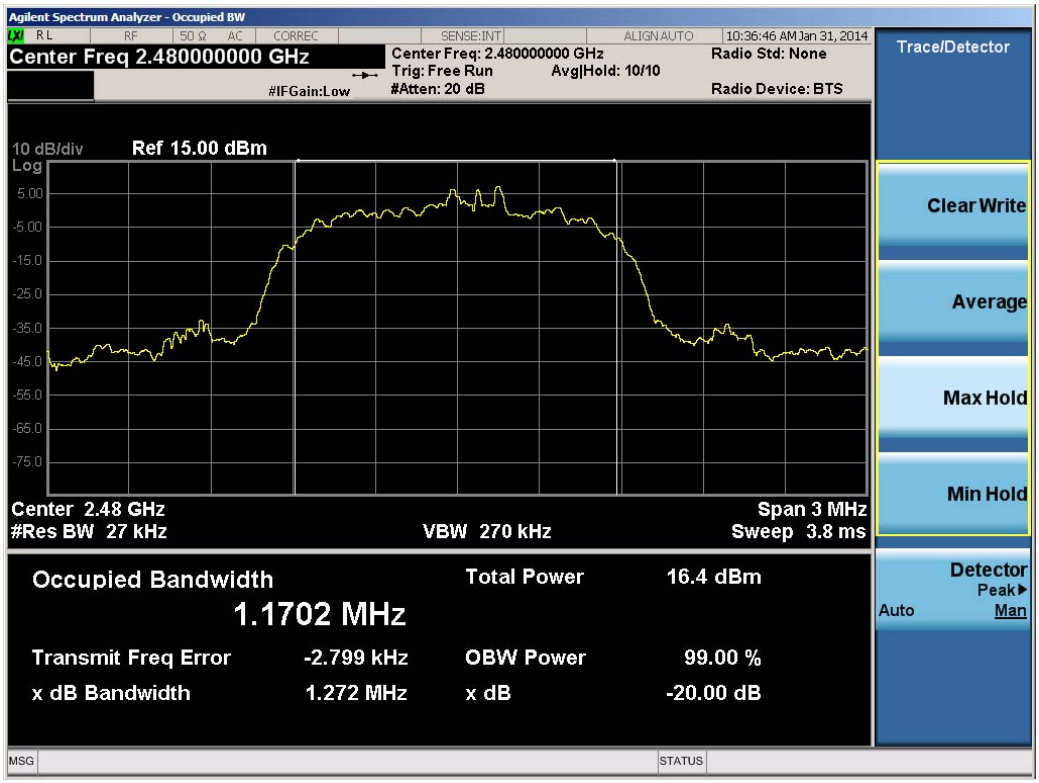

Plot 6-9. 20dB Bandwidth Plot (Bluetooth, 3Mbps – Ch. 78)

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6.3 Output Power Measurement

§15.247 (b)(1); RSS-210 (A8.4 (2))

Measurement is made while the EUT is operating in non-hopping transmission mode. The powers shown below were measured using a spectrum analyzer with a Bluetooth signaling test set (Agilent Model: N4010A) used only to maintain a Bluetooth link with the EUT. Peak power measurements are performed in the analyzers' swept spectrum mode using a peak detector with RBW = 3MHz and VBW ≥ RBW. Average power data is provided to determine the need for Bluetooth SAR testing according to KDB 447498 D01 v05r01. Average power measurements are performed using the analyzer's "burst power" function with RBW = 3MHz. The burst power function triggers on a single burst set to maximum power and measures the maximum average power over the on-time. ***The maximum permissible output power is 1 Watt.***

This unit was tested with all possible data rates and the highest peak power is reported with the unit transmitting at 3Mbps.

Frequency [MHz]	Data Rate [Mbps]	Channel No.	Peak Conducted Power		Avg Conducted Power	
			[dBm]	[mW]	[dBm]	[mW]
2402	1.0	0	7.44	5.544	7.27	5.332
2441	1.0	39	9.62	9.162	9.44	8.796
2480	1.0	78	8.04	6.362	7.87	6.119
2402	2.0	0	8.34	6.819	6.23	4.194
2441	2.0	39	10.52	11.267	8.47	7.030
2480	2.0	78	8.86	7.697	6.68	4.660
2402	3.0	0	8.58	7.213	6.24	4.209
2441	3.0	39	10.77	11.937	8.49	7.061
2480	3.0	78	9.09	8.108	6.87	4.863

Table 6-3. Conducted Output Power Measurements

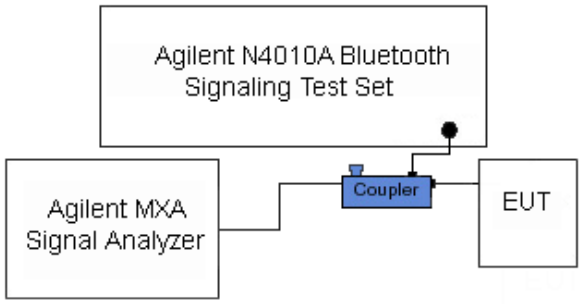

Figure 6-2. Test Instrument & Measurement Setup

Note

Final results were obtained using calibrated couplers, attenuators and cables. The following formula was used:

Output Power (dBm) = Raw Analyzer Level (dBm) + Cable Loss (dB) + Loss in Directional Coupler/Insertion Loss (dB)

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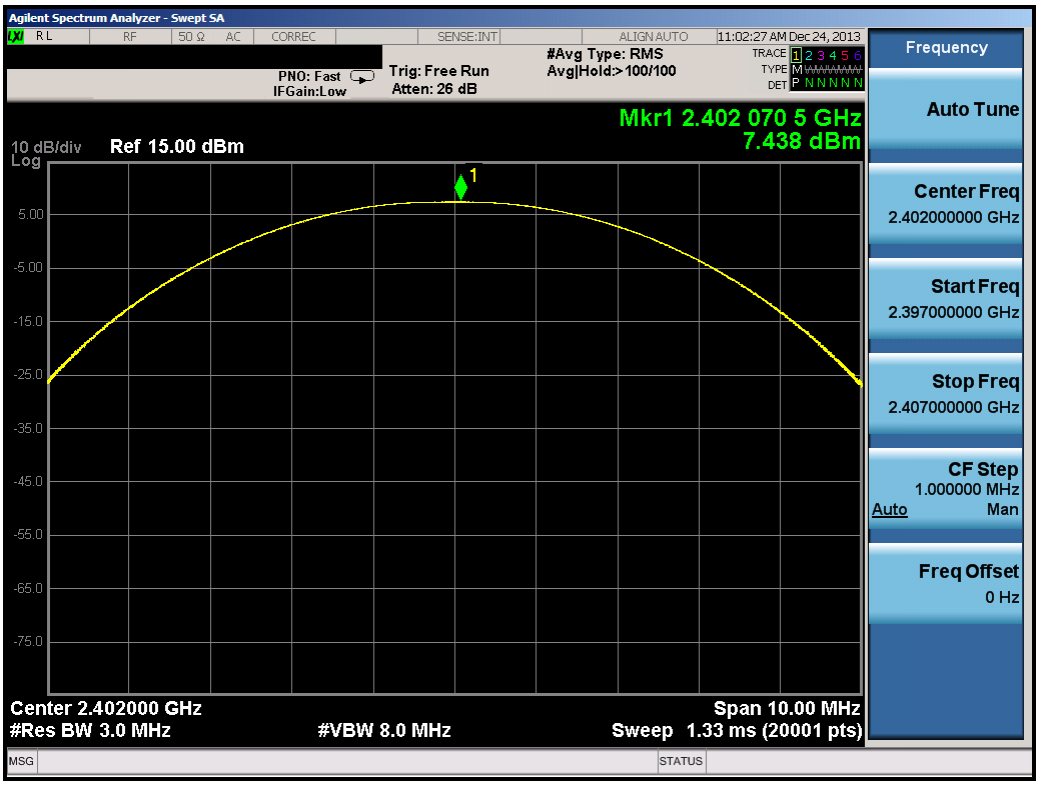
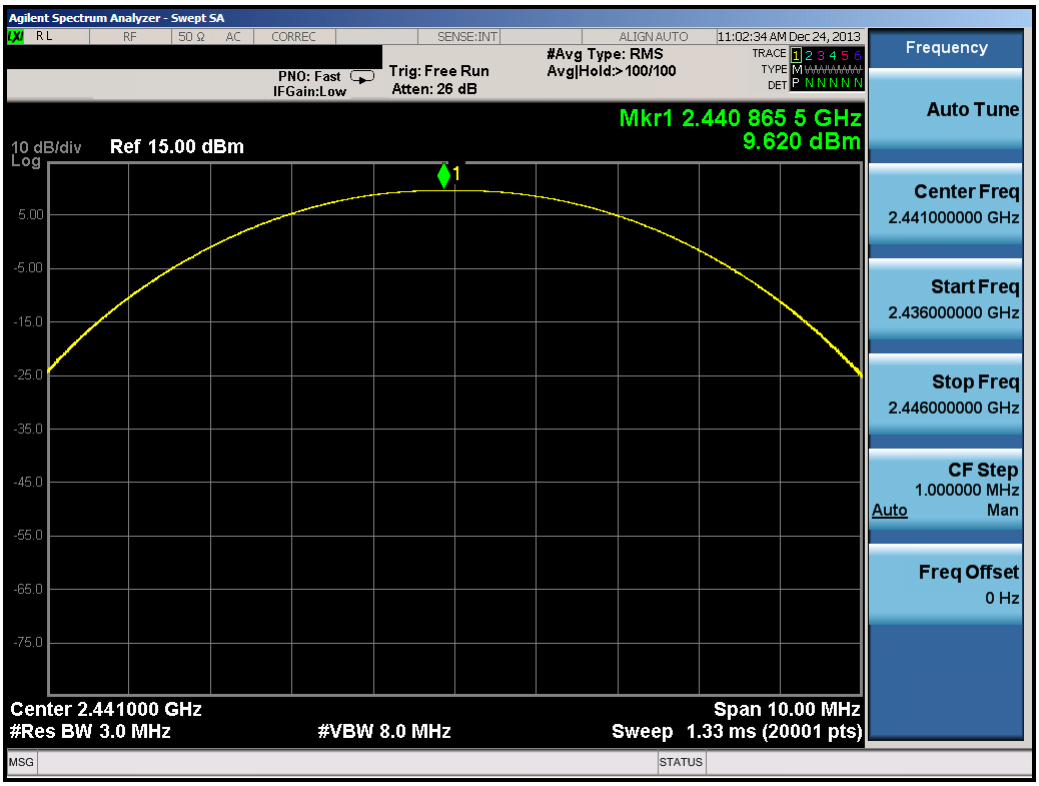


Plot 6-10. Peak Conducted Power (1Mbps – Ch. 0)



Plot 6-11. Peak Conducted Power (1Mbps – Ch. 39)

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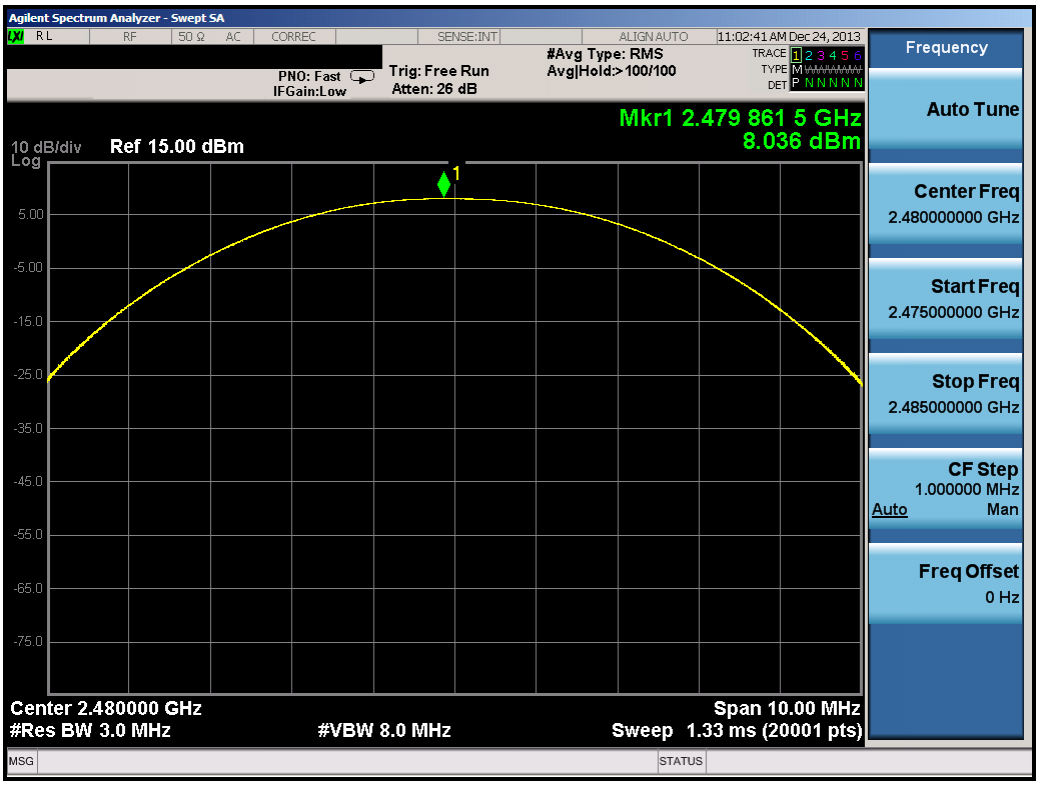
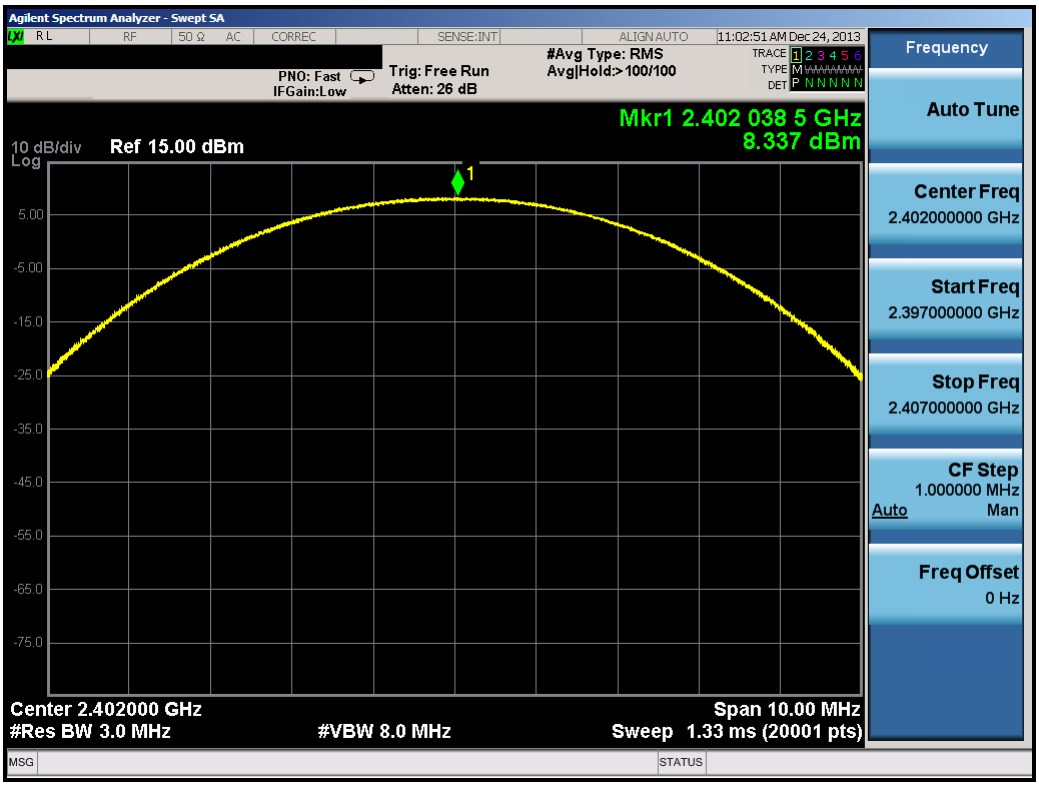


Plot 6-12. Peak Conducted Power (1Mbps – Ch. 78)



Plot 6-13. Peak Conducted Power (2Mbps – Ch. 0)

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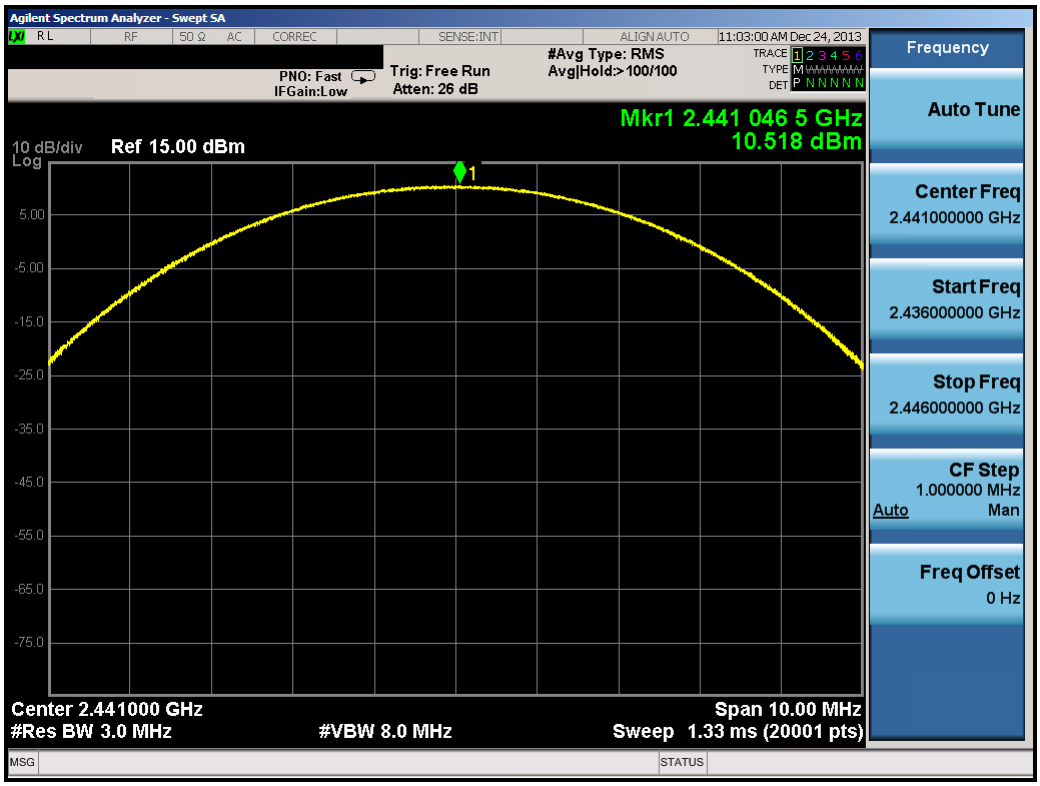
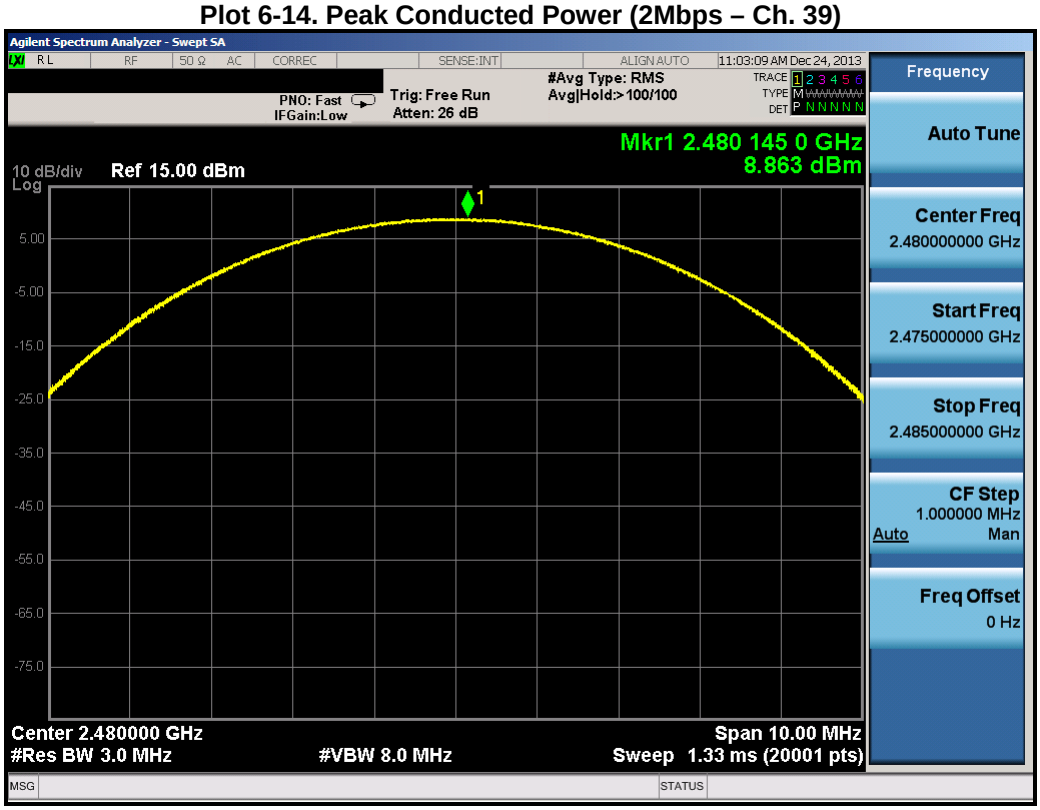


Plot 6-14. Peak Conducted Power (2Mbps – Ch. 39)



Plot 6-15. Peak Conducted Power (2Mbps – Ch. 78)

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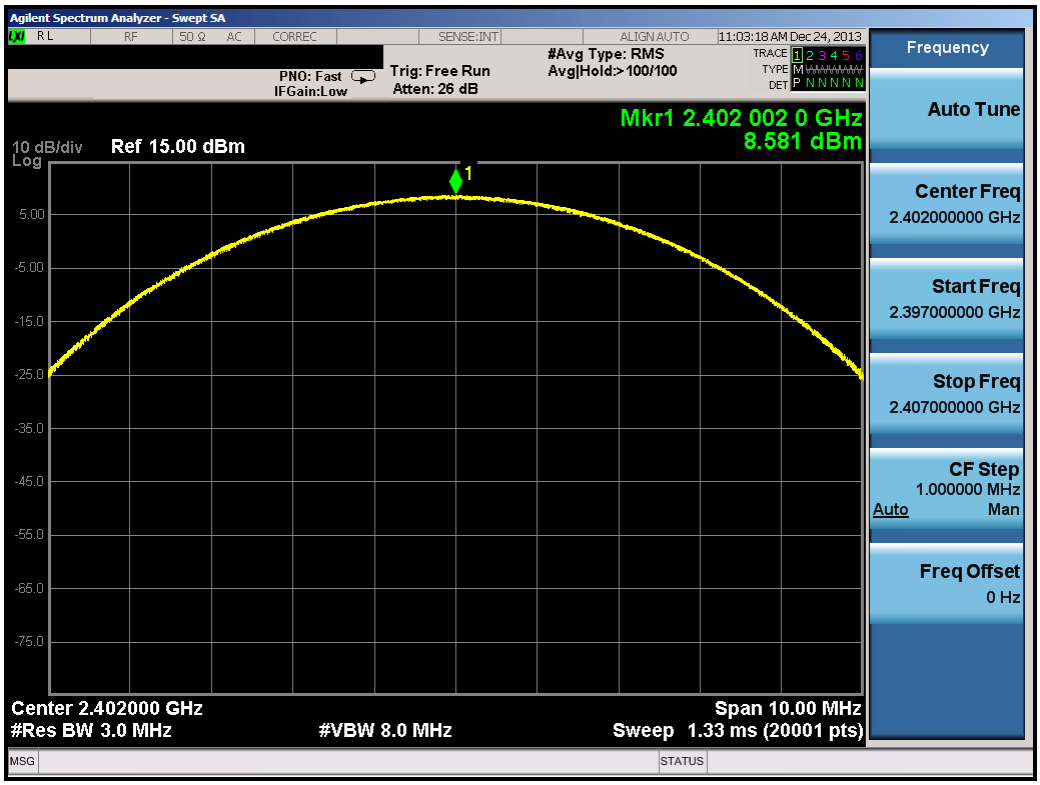
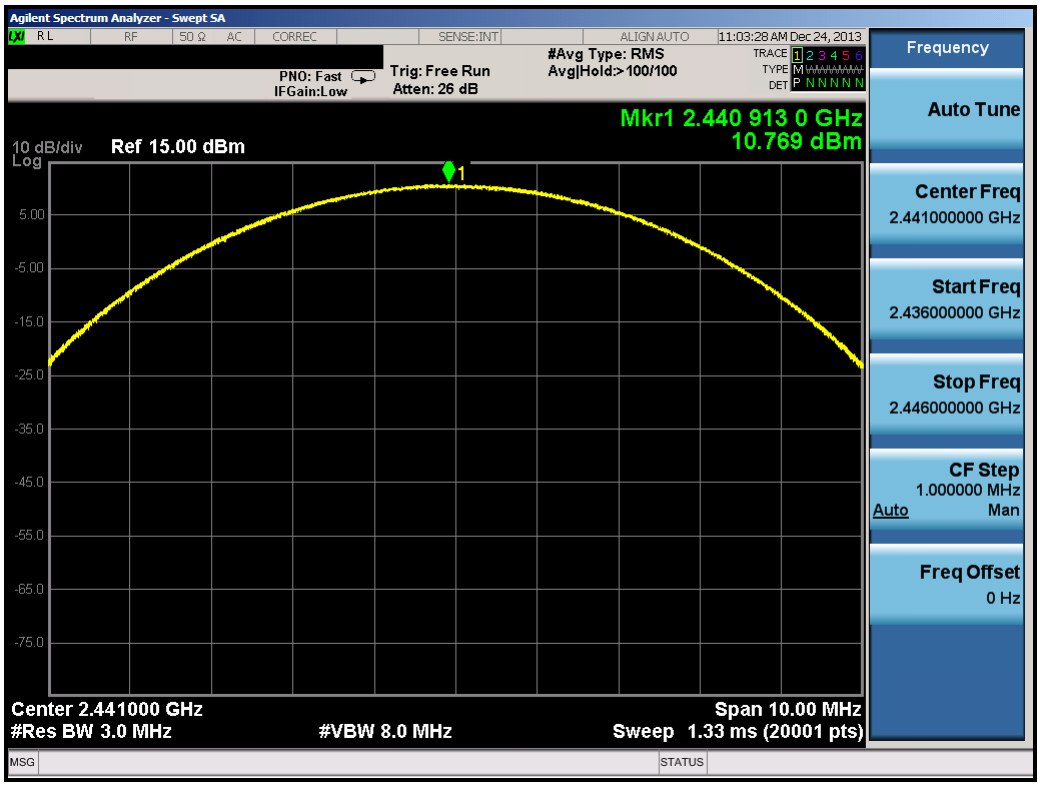


Plot 6-16. Peak Conducted Power (3Mbps – Ch. 0)



Plot 6-17. Peak Conducted Power (3Mbps – Ch. 39)

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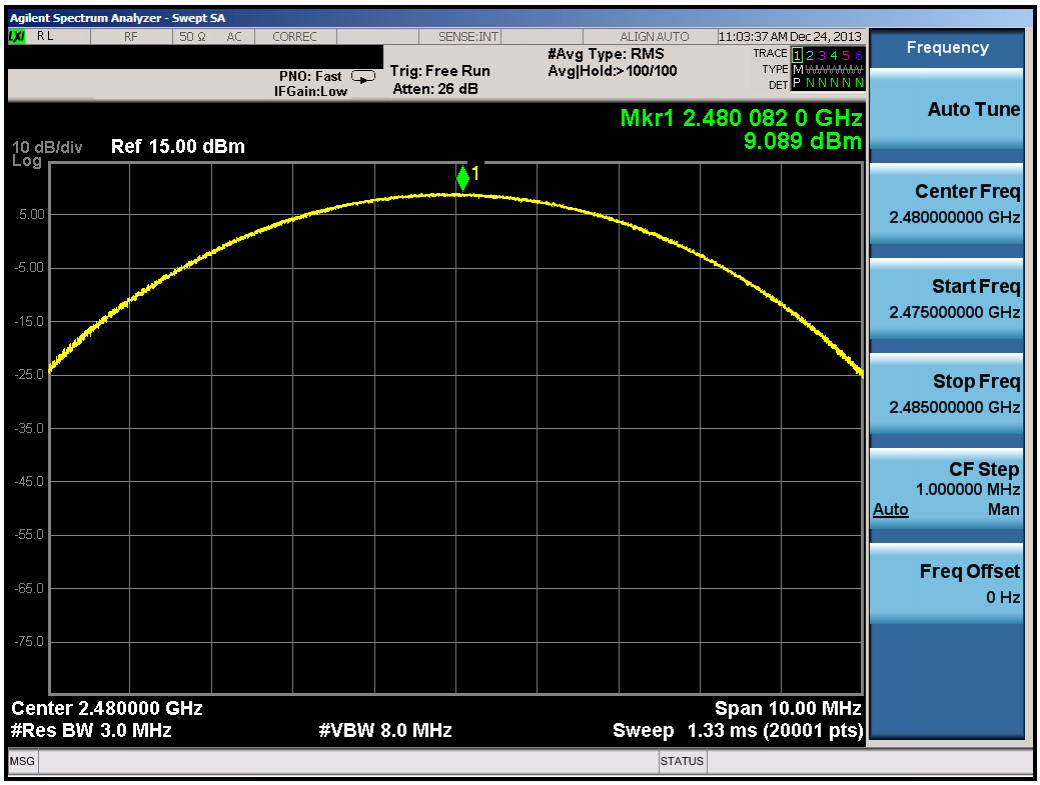

Plot 6-18. Peak Conducted Power (3Mbps – Ch. 78)

Plot 6-19. Average Conducted Power (1Mbps – Ch. 0)

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Plot 6-20. Average Conducted Power (1Mbps – Ch. 39)

Plot 6-21. Average Conducted Power (1Mbps – Ch. 78)

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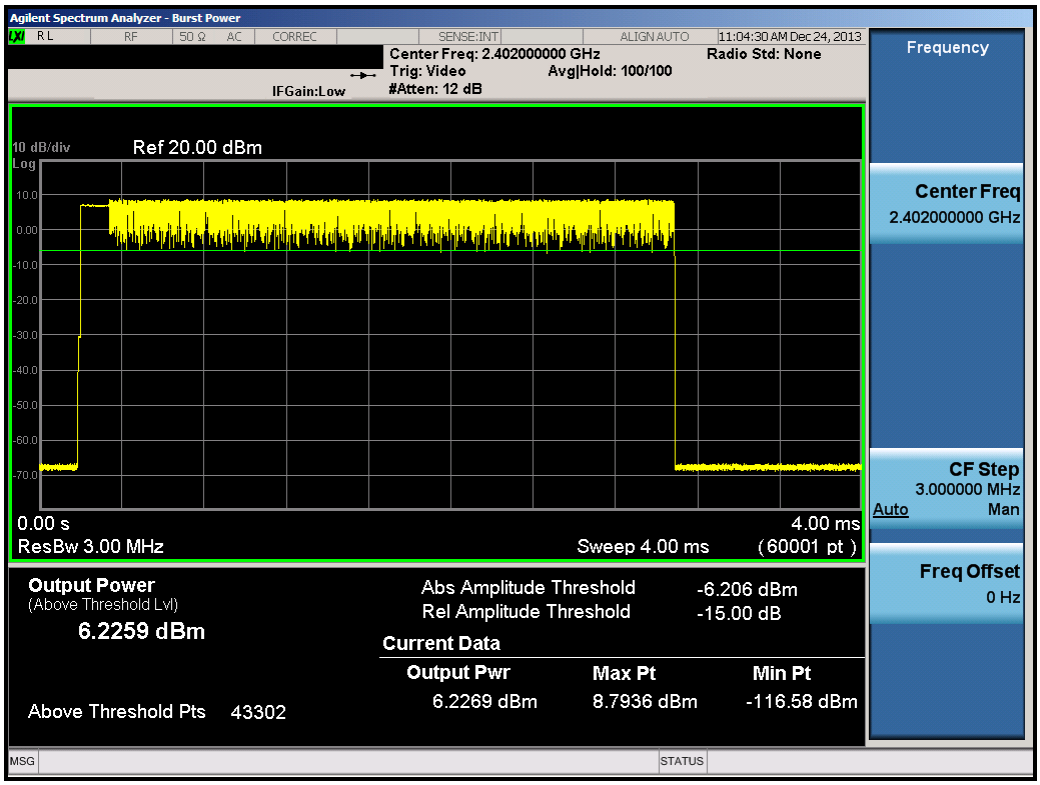
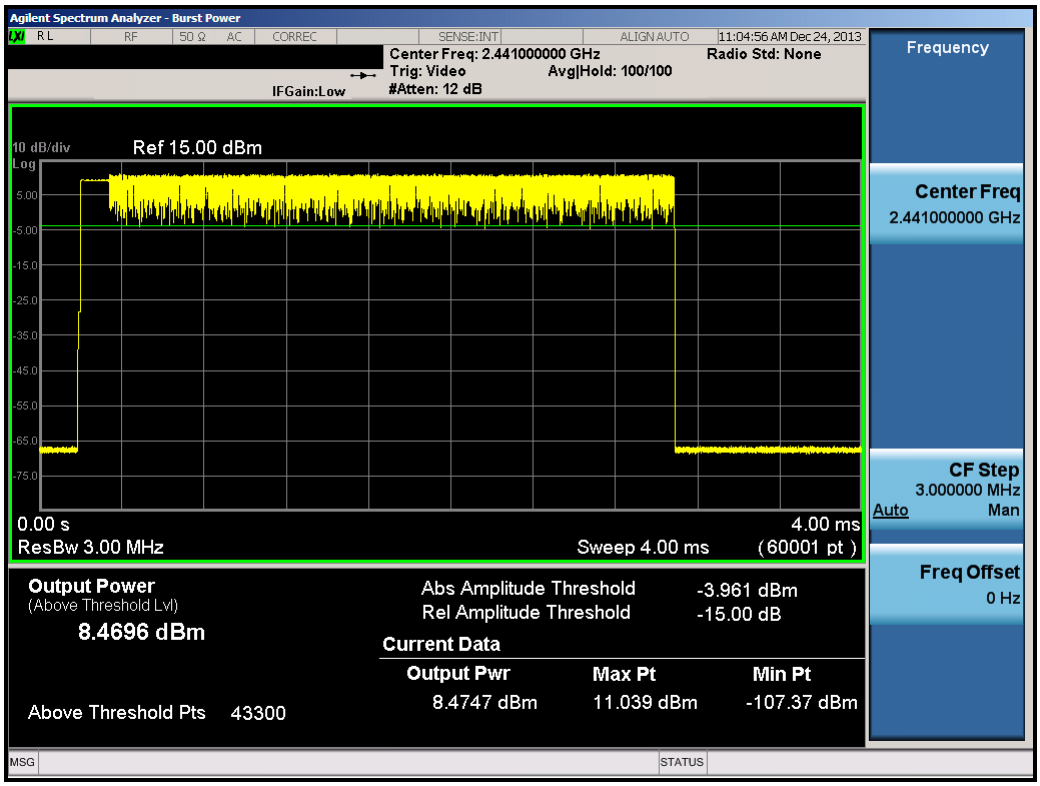


Plot 6-22. Average Conducted Power (2Mbps – Ch. 0)



Plot 6-23. Average Conducted Power (2Mbps – Ch. 39)

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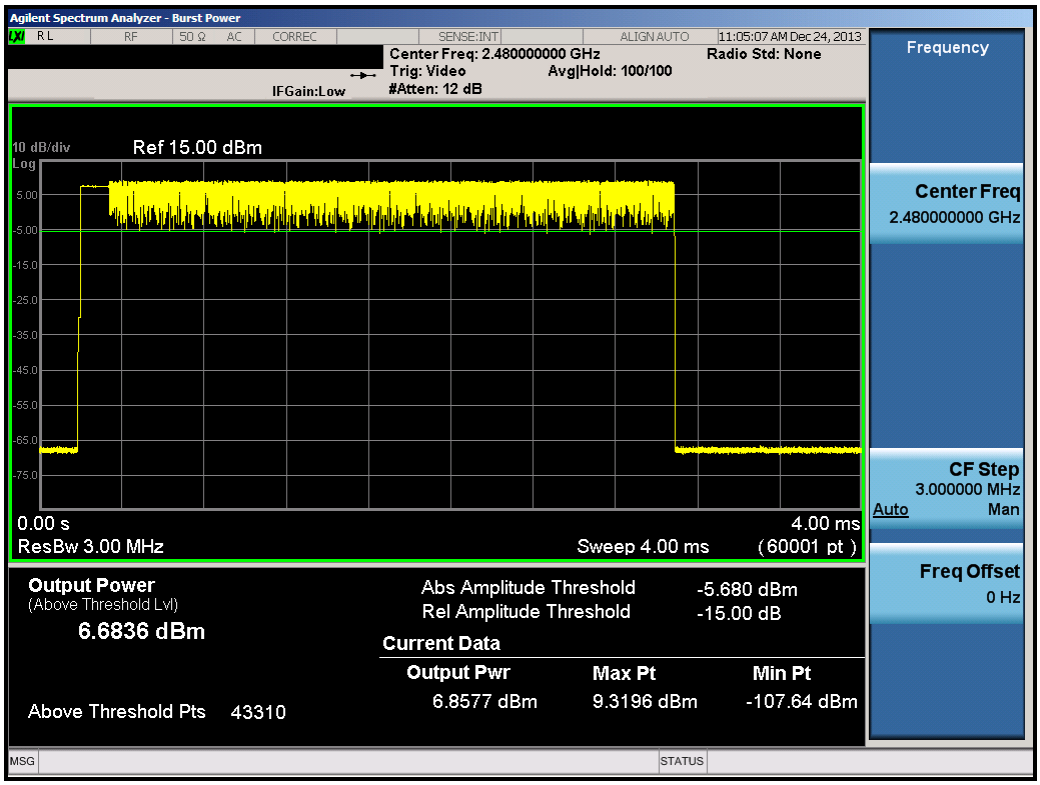
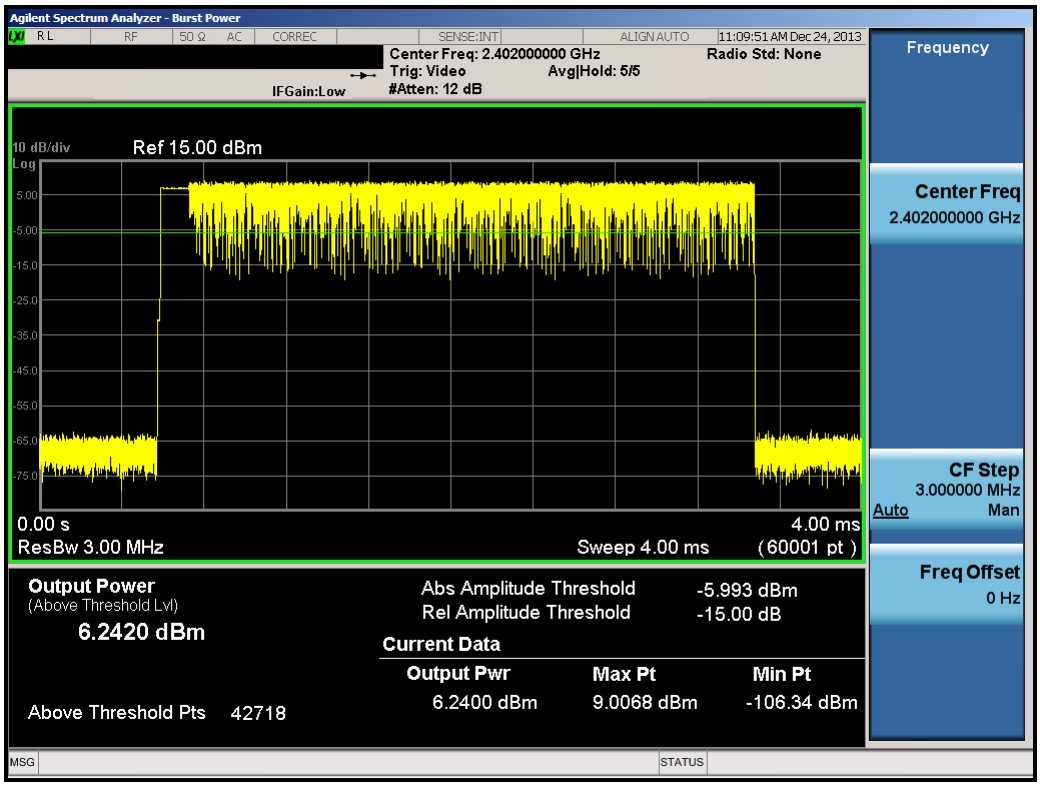


Plot 6-24. Average Conducted Power (2Mbps – Ch. 78)



Plot 6-25. Average Conducted Power (3Mbps – Ch. 0)

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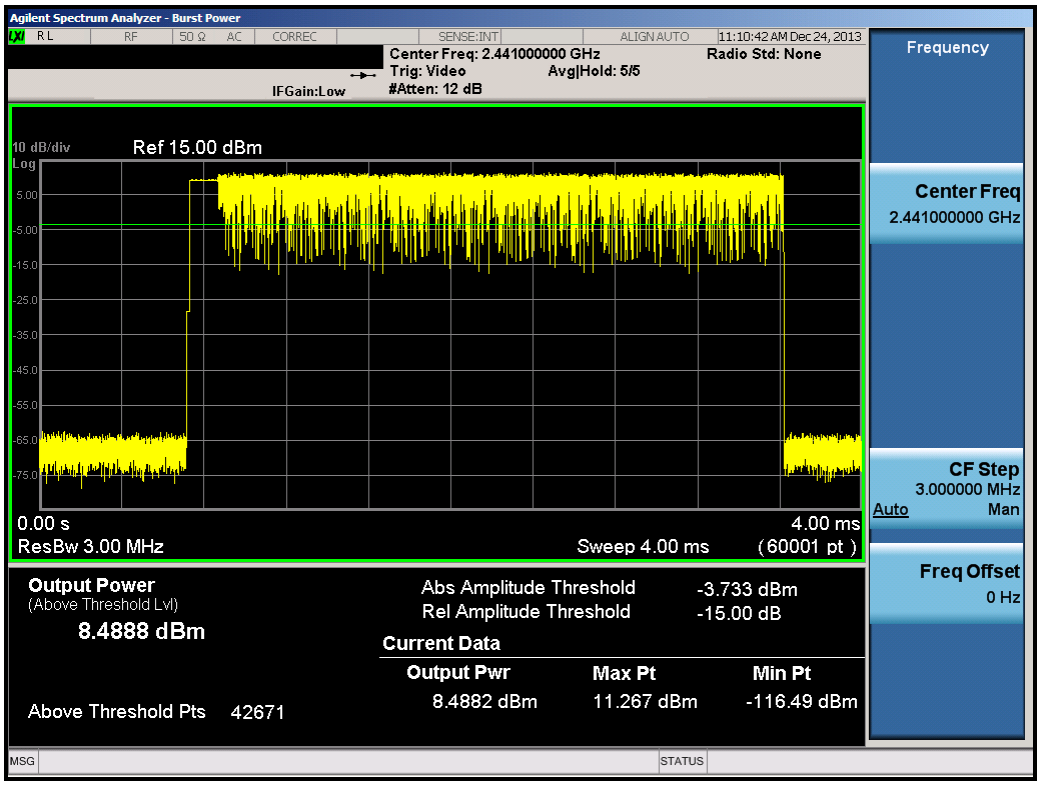
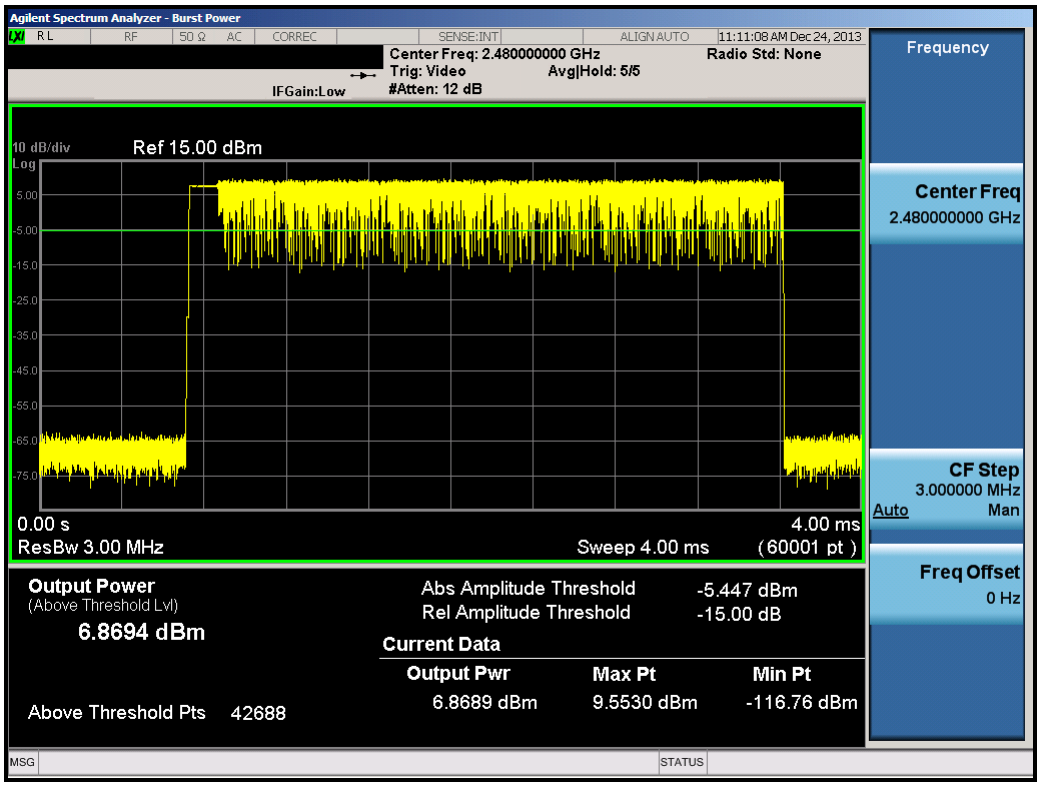


Plot 6-26. Average Conducted Power (3Mbps – Ch. 39)



Plot 6-27. Average Conducted Power (3Mbps – Ch. 78)

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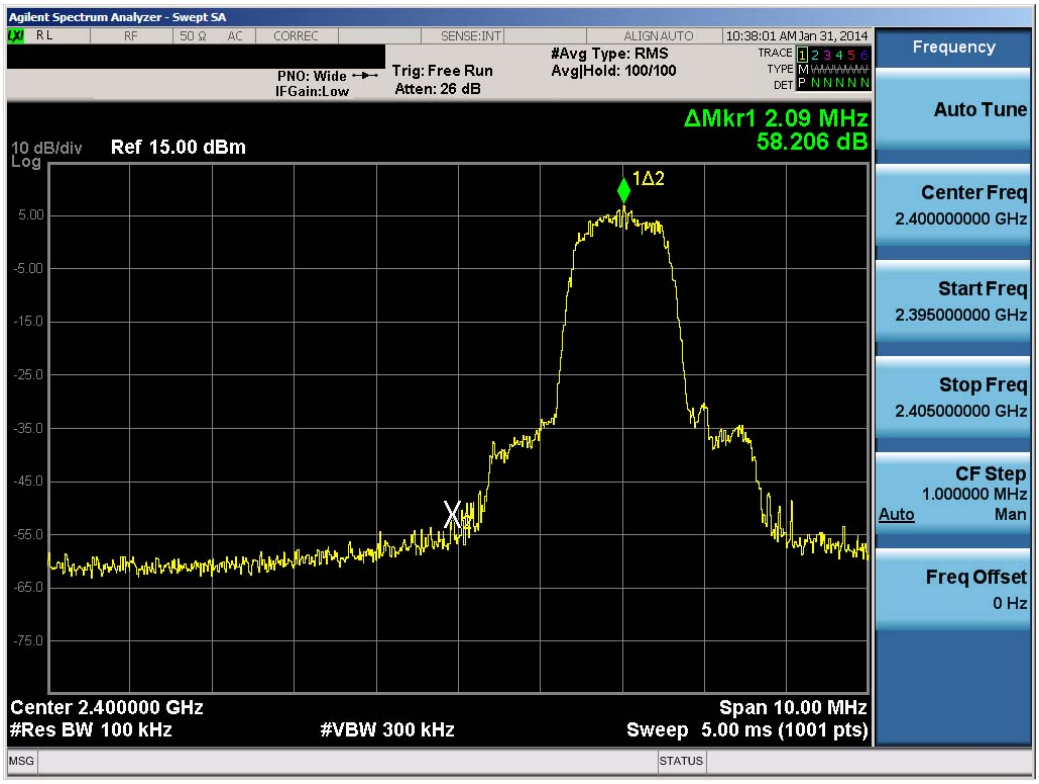
6.4 Band Edge Compliance

§15.247 (d); RSS-210 (A8.5)

Measurement is taken at the highest point located outside of the emission bandwidth. ***The maximum permissible emission level is 20 dBc. Any emission lying outside of the emission bandwidth and in a restricted band is subject to a field strength limit specified in Section 15.209 of the Title 47 CFR.***

Out of band conducted spurious emissions at the band edge were investigated for all data rates and the worst case emissions were found with the EUT transmitting at 3Mbps. Band edge emissions were also investigated with the EUT transmitting in all data rates. Plots of the worst case emissions are shown below.



Plot 6-28. Band Edge Plot (Bluetooth with Hopping Disabled, 3Mbps – Ch. 0)

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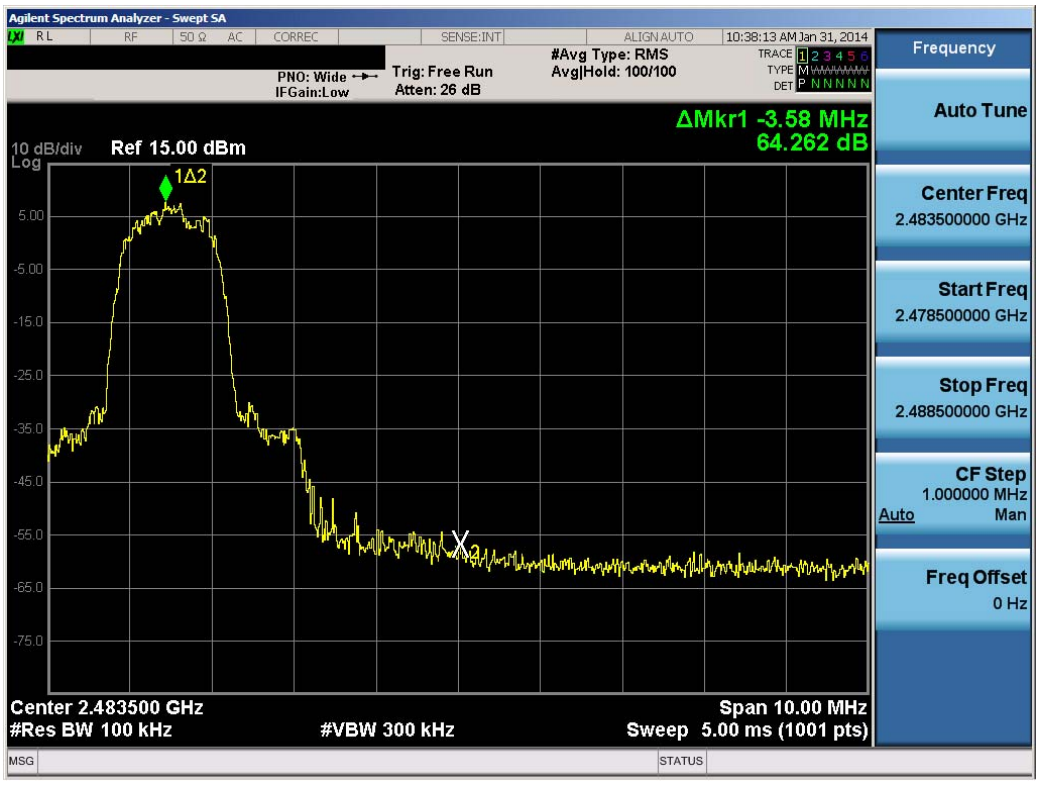

Plot 6-29. Band Edge Plot (Bluetooth with Hopping Disabled, 3Mbps – Ch. 78)

Plot 6-30. Band Edge Plot (Bluetooth with Hopping Enabled, 3Mbps)

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Plot 6-31. Band Edge Plot (Bluetooth with Hopping Enabled, 3Mbps)

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6.5 Carrier Frequency Separation

§15.247 (a)(1); RSS-210 (A8.1 (2))

Measurement is made with EUT operating in hopping mode. ***The minimum permissible channel separation for this system is 2/3 the value of the 20dB BW.***

The EUT complies with the minimum channel separation requirement when it is operating in 1x/EDR mode using 79 channels and when operating in AFH mode using 20 channels.

Frequency [MHz]	Data Rate [Mbps]	Channel No.	Min. Channel Separation [MHz]
2402	1.0	0	0.680
2441	1.0	39	0.631
2480	1.0	78	0.673
2402	2.0	0	0.856
2441	2.0	39	0.862
2480	2.0	78	0.875
2402	3.0	0	0.853
2441	3.0	39	0.851
2480	3.0	78	0.854

Table 6-4. Minimum Channel Separation

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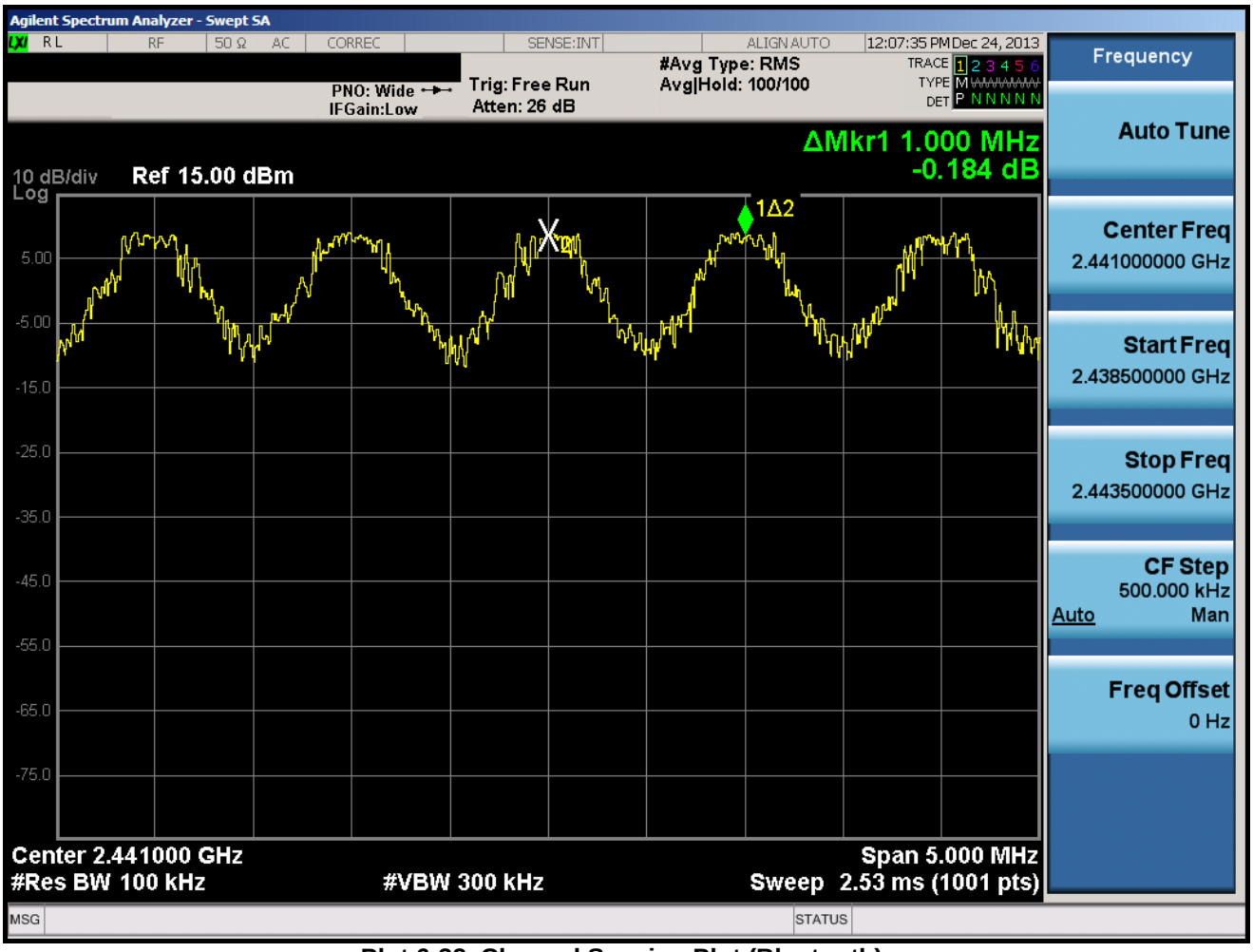

Plot 6-32. Channel Spacing Plot (Bluetooth)

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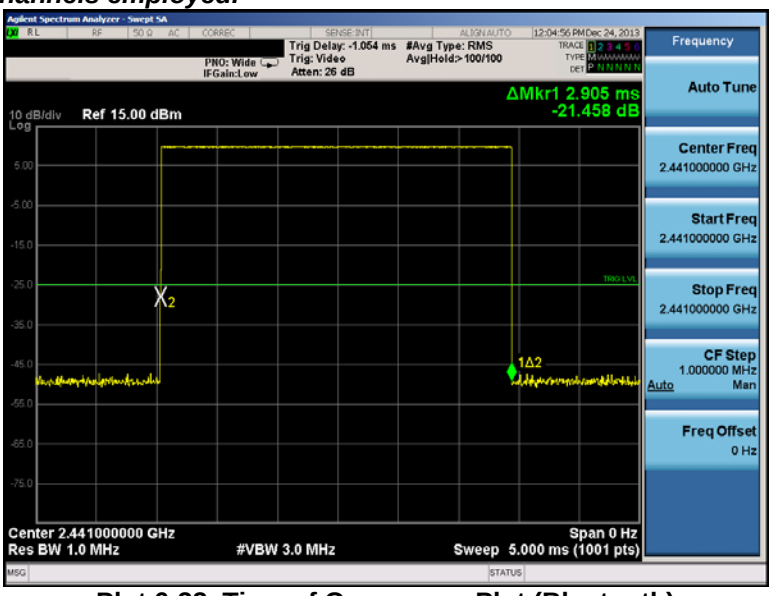
6.6 Time of Occupancy

§15.247 (a)(1)(iii); RSS-210 (A8.1 (4))

Measurement is made while EUT is operating in hopping mode with the spectrum analyzer set to zero span. ***The maximum permissible time of occupancy is 400 ms within a period of 400ms multiplied by the number of hopping channels employed.***



Plot 6-33. Time of Occupancy Plot (Bluetooth)

Bluetooth Time of Occupancy Calculation

Typically, Bluetooth 1x/EDR mode has a channel hopping rate of 1600 hops/s. Since 1x/EDR modes use 5 transmit and 1 receive slot, for a total of 6 slots, the Bluetooth transmitter is actually hopping at a rate of 1600 / 6 = 266.67 hops/s/slot

- 400ms x 79 hopping channels = 31.6 sec (Time of Occupancy Limit)
- Worst case BT has 266.67 hops/second (for 1x/EDR modes with DH5 operation)
- 266.67 hops/second / 79 channels = 3.38 hops/second (# of hops/second on one channel)
- 3.38 hops/second/channel x 31.6 seconds = 106.67 hops (# hops over a 31.6 second period)
- 106.67 hops x 2.905 ms/channel = 309.87ms (worst case dwell time for one channel in 1x/EDR modes)

With AFH, the number of channels is reduced to a minimum of 20 channels and the channel hopping rate is reduced by 50% to 800 hops/s. AFH mode also uses 6 total slots so the Bluetooth transmitter hops at a rate of 800 / 6 = 133.3 hops/s/slot

- 400ms x 20 hopping channels = 8 sec (Time of Occupancy Limit)
- Worst case BT has 133.3 hops/second/slot (for AFH mode with DH5 operation)
- 133.3 hops/s / 20 channels = 6.67 hops/second (# of hops/second on one channel)
- 6.67 hops/s / channel x 8 seconds = 53.34 hops (# hops over a 8 second period)
- 53.34 hops x 2.905 ms/channel = 154.95 ms (worst case dwell time for one channel in AFH mode)

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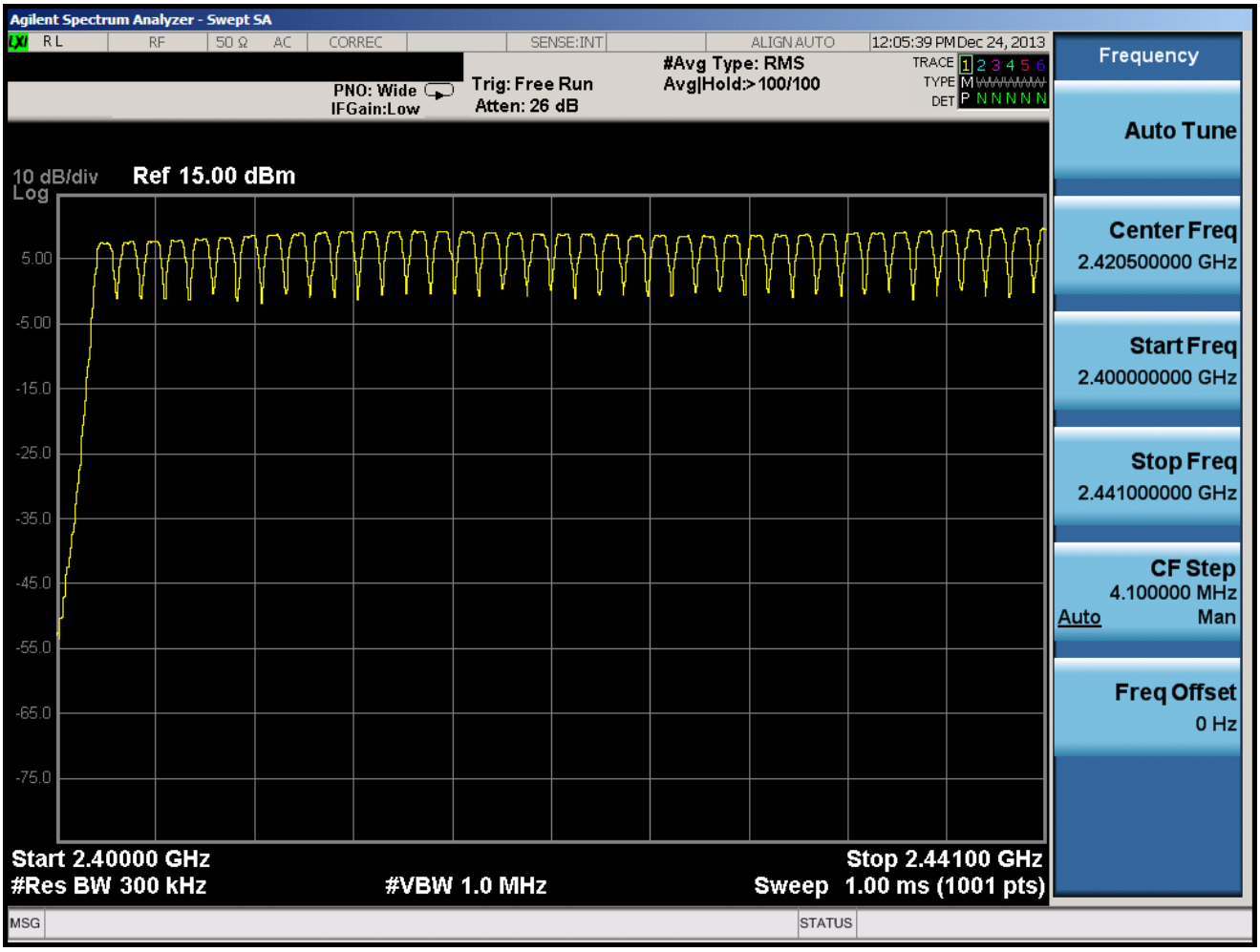
6.7 Number of Hopping Channels

§15.247 (a)(1)(iii); RSS-210 (A8.1 (4))

Measurement is made while EUT is operating in hopping mode. ***This frequency hopping system must employ a minimum of 15 hopping channels.***

In AFH mode, this device operates using 20 channels so the requirement for minimum number of hopping channels is satisfied.



Plot 6-34. Low End Spectrum Channel Hopping Plot (Bluetooth)

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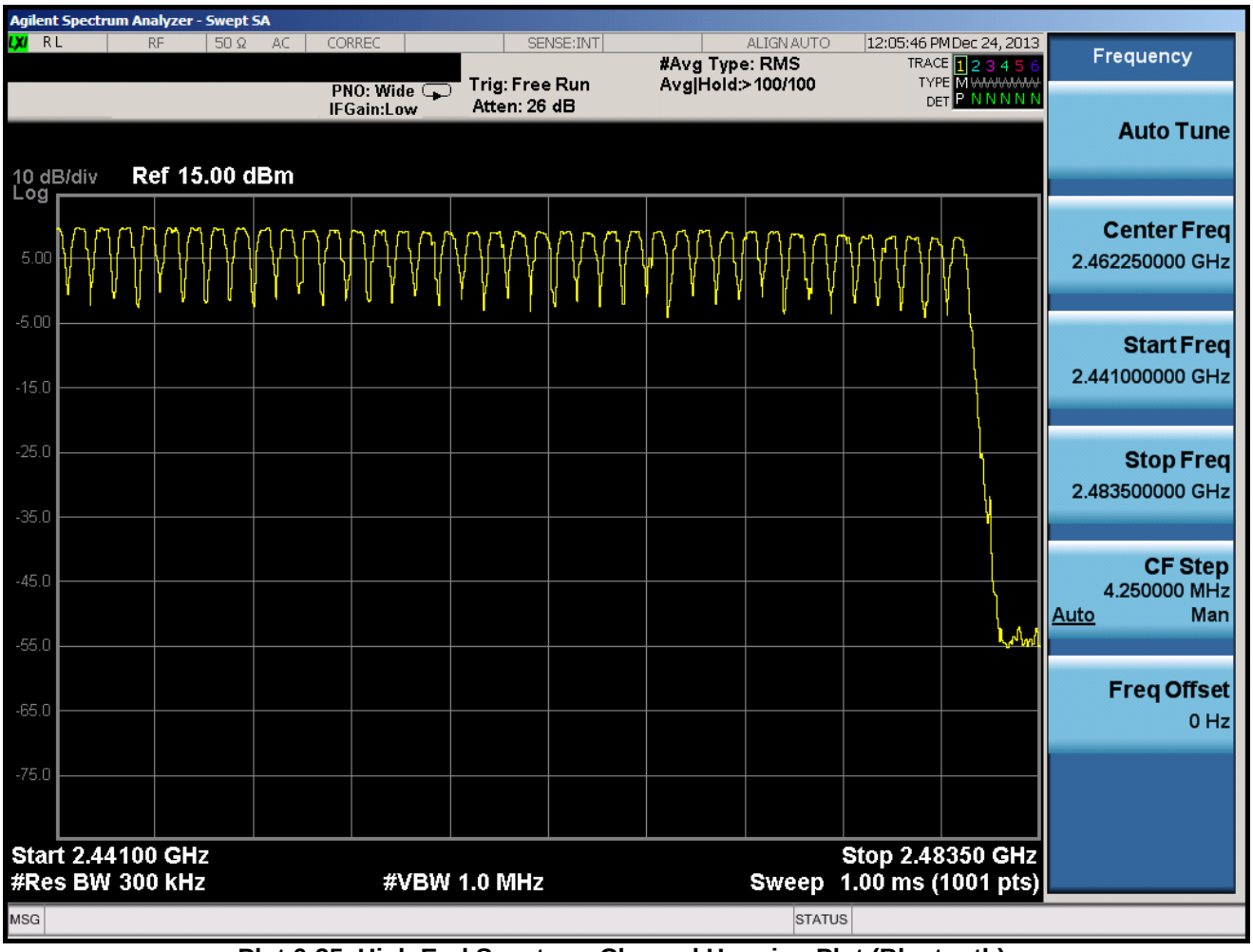

Plot 6-35. High End Spectrum Channel Hopping Plot (Bluetooth)

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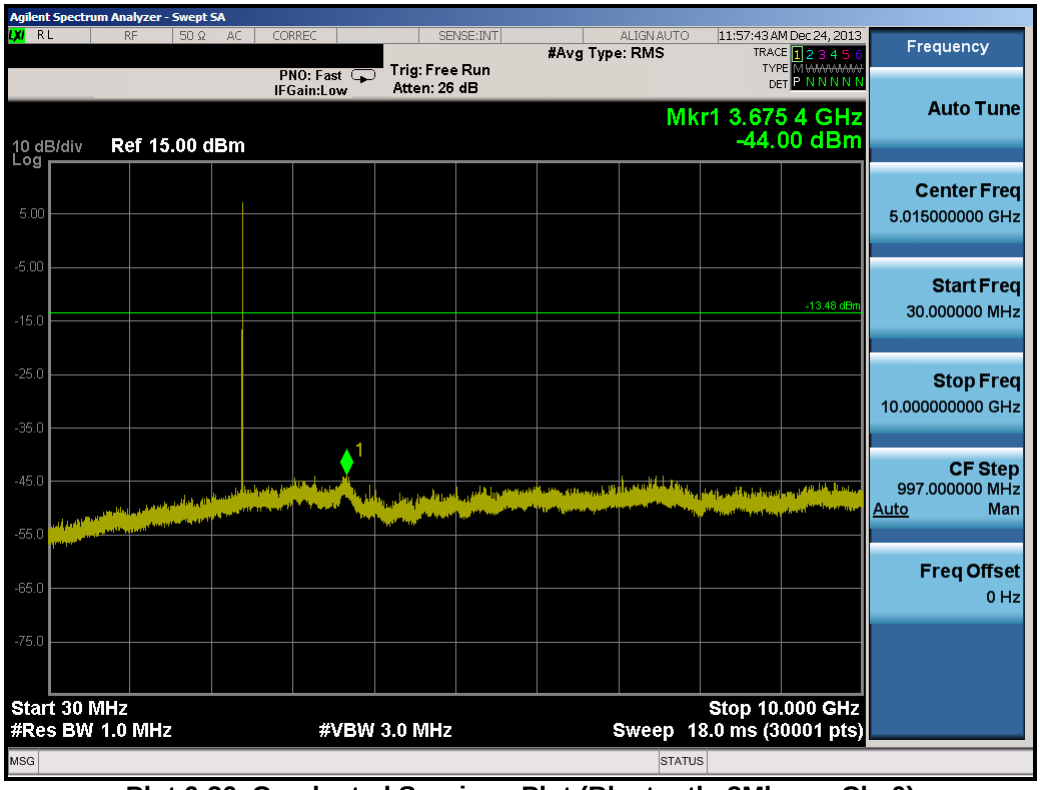
6.8 Conducted Spurious Emissions

§15.247 (d)

Out of band conducted spurious emissions were investigated for all data rates and the worst case emissions were found with the EUT transmitting at 3Mbps. Plots of the worst case emissions are shown below.

The display line shown in the following plots denotes the limit at 20dB below the fundamental emission level measured in a 100kHz bandwidth. However, since the traces in the following plots are measured with a 1MHz RBW, the display line may not necessarily appear to be 20dB below the level of the fundamental in a 1MHz bandwidth.



Plot 6-36. Conducted Spurious Plot (Bluetooth, 3Mbps – Ch. 0)

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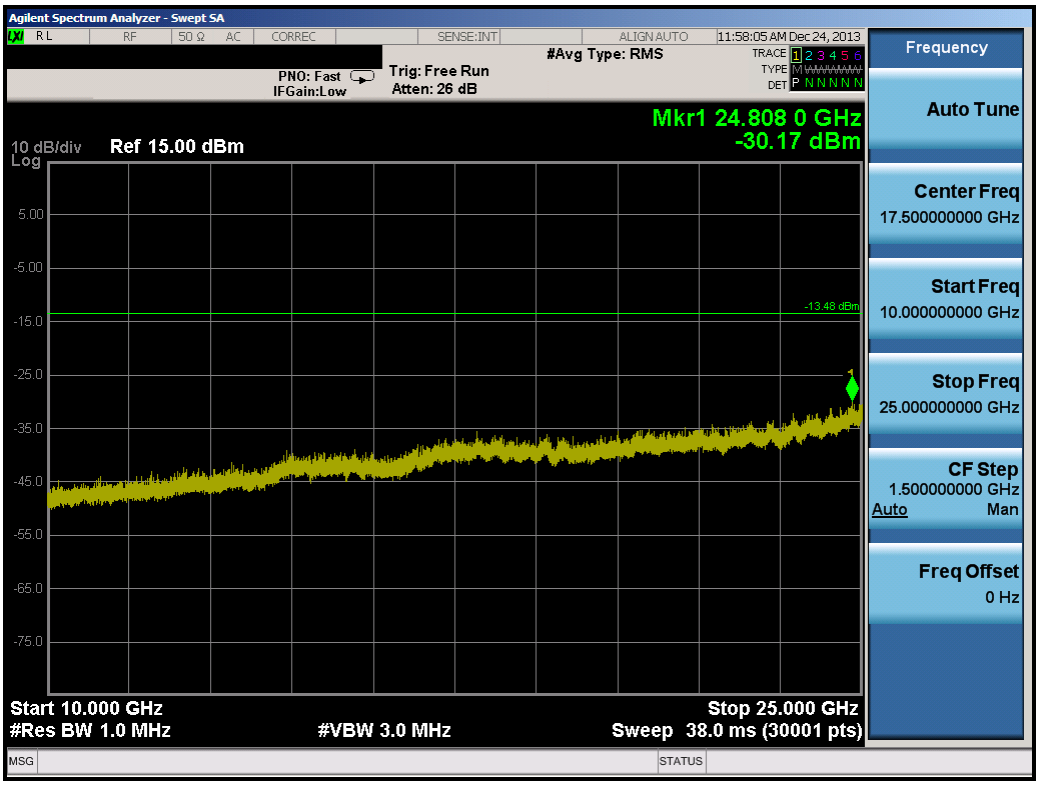
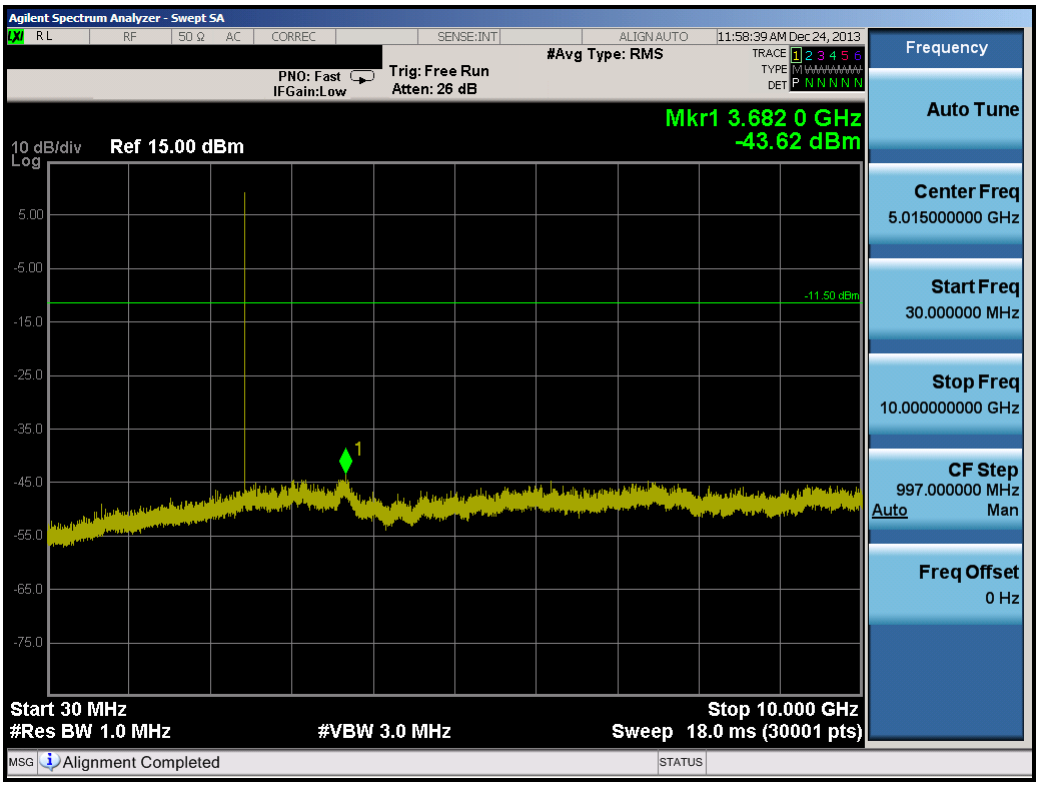


Plot 6-37. Conducted Spurious Plot (Bluetooth, 3Mbps – Ch. 0)



Plot 6-38. Conducted Spurious Plot (Bluetooth, 3Mbps – Ch. 39)

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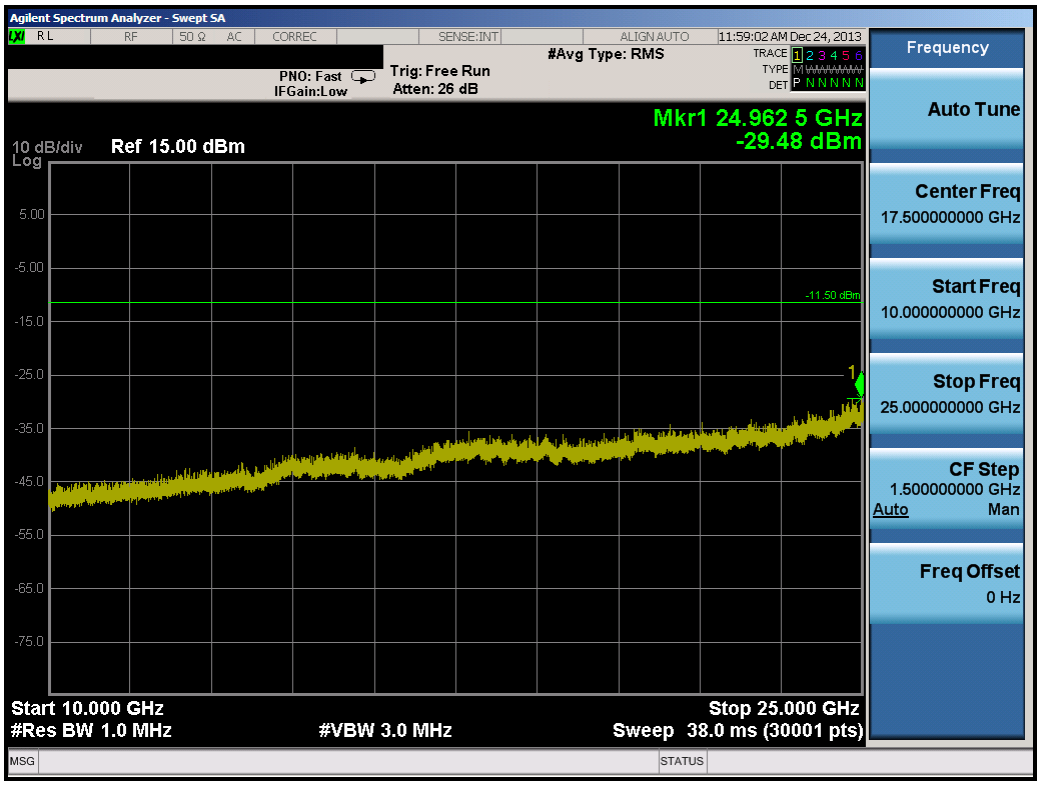
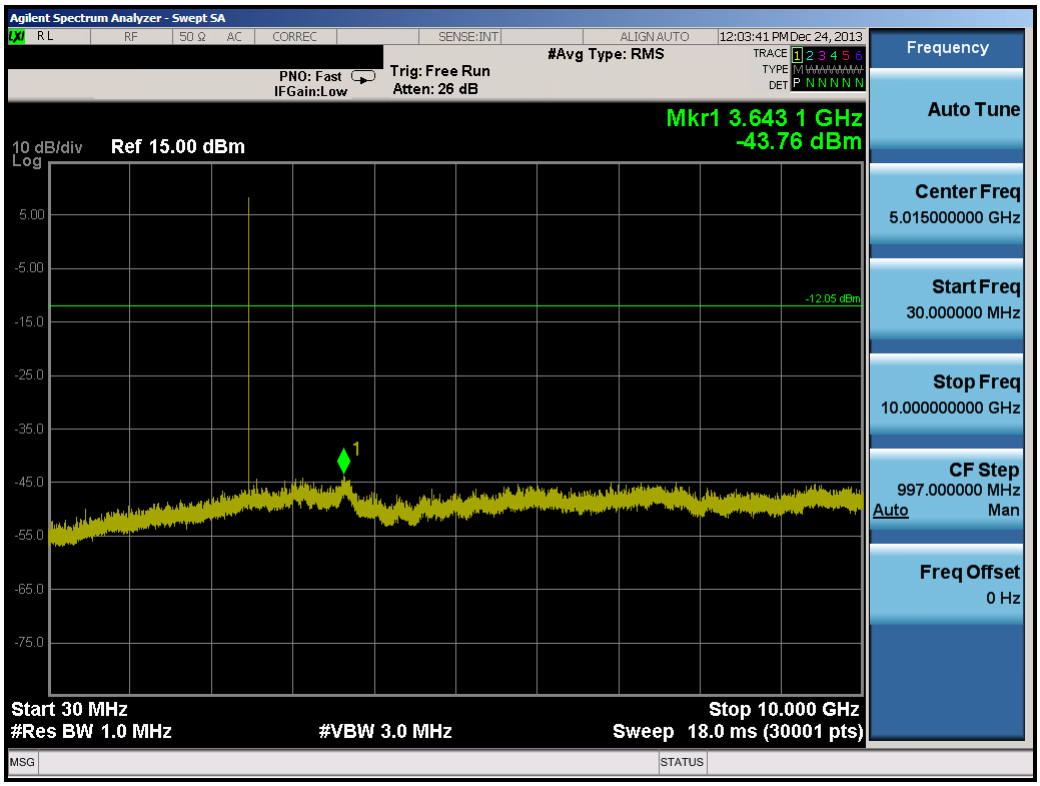


Plot 6-39. Conducted Spurious Plot (Bluetooth, 3Mbps – Ch. 39)



Plot 6-40. Conducted Spurious Plot (Bluetooth, 3Mbps – Ch. 78)

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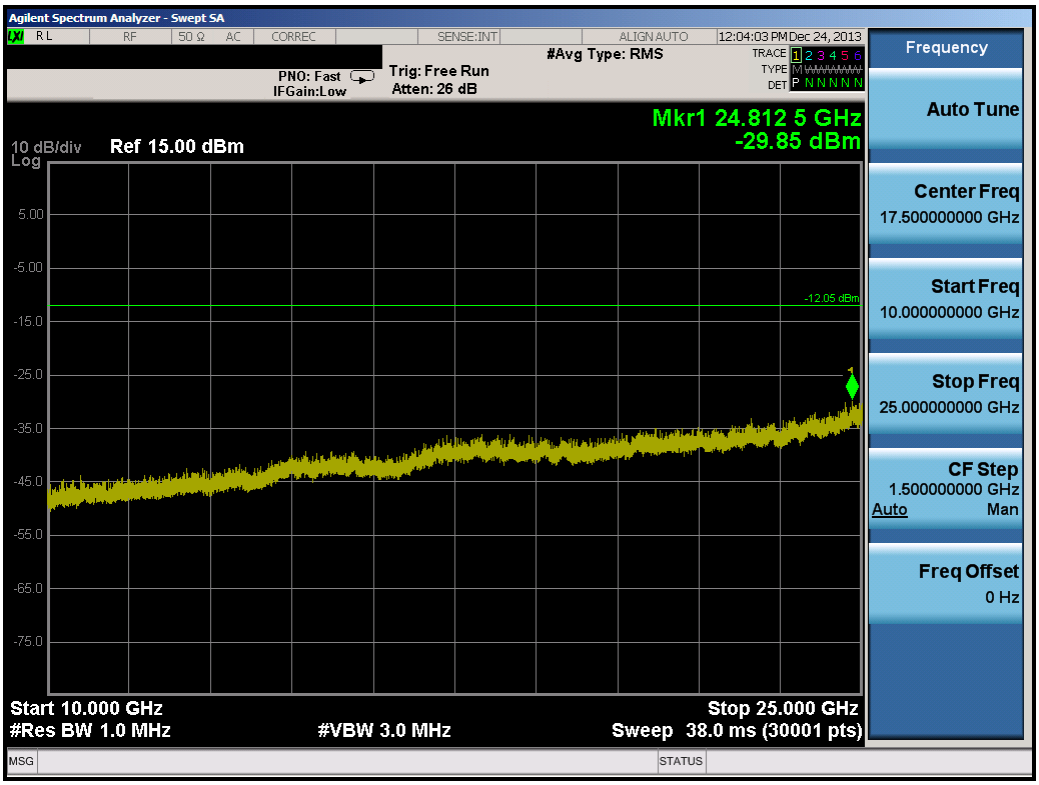

Plot 6-41. Conducted Spurious Plot (Bluetooth, 3Mbps – Ch. 78)

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6.9 Radiated Spurious Emission Measurements

§15.205 & §15.209, §15.247 (d); RSS-210 (A8.5)

Frequency	Field Strength [μV/m]	Measured Distance [Meters]
0.009 – 0.490 MHz	2400/F (kHz)	300
0.490 – 1.705 MHz	24000/F (kHz)	30
1.705 – 30.00 MHz	30	30
30.00 – 88.00 MHz	100	3
88.00 – 216.0 MHz	150	3
216.0 – 960.0 MHz	200	3
Above 960.0 MHz	500	3

Table 6-5. Radiated Limits

Sample Calculation

- Field Strength Level $_{[dB\mu V/m]}$ = Analyzer Level $_{[dBm]}$ + 107 + AFCL $_{[dB/m]}$ + Duty Cycle Correction $_{[dB]}$
- AFCL $_{[dB/m]}$ = Antenna Factor $_{[dB/m]}$ + Cable Loss $_{[dB]}$
- Margin $_{[dB]}$ = Field Strength Level $_{[dB\mu V/m]}$ – Limit $_{[dB\mu V/m]}$

Duty Cycle Correction Factor Calculation

- Channel hop rate = 800 hops/second (AFH Mode)
- Adjusted channel hop rate for DH5 mode = 133.33 hops/second
- Time per channel hop = 1 / 133.33 hops/second = 7.5 ms
- Time to cycle through all channels = 7.5 x 20 channels = 150 ms
- Number of times transmitter hits on one channel = 100 ms / 150 ms = 1 time(s)
- Worst case dwell time = 7.5 ms
- Duty cycle correction factor = $20\log_{10}(7.5ms/100ms)$ = -22.5 dB

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Test Notes

1. All emissions lying in restricted bands specified in §15.205 are below the limit shown in Table 6-5.
2. No significant radiated emissions were found in the 2310 - 2390MHz restricted band.
3. Average measurements > 1GHz using RBW = 1MHz and VBW = 1kHz $\geq 1/\tau$ Hz, where τ = pulse width in seconds. Peak measurements > 1GHz using RBW = 1MHz and VBW = 3MHz. Both average and peak measurements were made using a peak detector.
4. The antenna is manipulated through typical positions, polarity and length during the tests. The EUT is manipulated through three orthogonal planes.
5. This unit was tested with its standard battery.
6. The spectrum is measured from 9kHz to the 10^{th} harmonic and the worst-case emissions are reported. Emissions whose levels were not within 20dB of the respective limits were not reported.
7. Average levels at -135 dBm and peak levels at -125dBm represent the analyzer noise floor and signify that no emission was detected.

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Radiated Spurious Emission Measurements (Cont'd)

§15.205 & §15.209, §15.247 (d); RSS-210 (A8.5)

Worst Case Mode:	Bluetooth
Worst Case Data Rate:	3Mbps
Measurement Distance:	3 Meters
Operating Frequency:	2402MHz
Channel:	0

Frequency [MHz]	Analyzer Level [dBm]	Detector	Pol [H/V]	AFCL [dB]	Duty Cycle Correction [dB]	Field Strength [dBµV/m]	Limit [dBµV/m]	Margin [dB]
4804.00	-103.67	Avg	H	41.41	-22.50	22.24	53.98	-31.74
4804.00	-95.94	Peak	H	41.41	0.00	52.47	73.98	-21.51
12010.00	-135.00	Avg	H	64.79	0.00	36.79	53.98	-17.19
12010.00	-125.00	Peak	H	64.79	0.00	46.79	73.98	-27.19

Table 6-6. Radiated Measurements

Worst Case Mode:	Bluetooth
Worst Case Data Rate:	3Mbps
Measurement Distance:	3 Meters
Operating Frequency:	2441MHz
Channel:	39

Frequency [MHz]	Analyzer Level [dBm]	Detector	Pol [H/V]	AFCL [dB]	Duty Cycle Correction [dB]	Field Strength [dBµV/m]	Limit [dBµV/m]	Margin [dB]
4882.00	-104.24	Avg	H	41.83	-22.50	22.09	53.98	-31.89
4882.00	-95.69	Peak	H	41.83	0.00	53.14	73.98	-20.84
7323.00	-135.00	Avg	H	48.56	0.00	20.56	53.98	-33.42
7323.00	-125.00	Peak	H	48.56	0.00	30.56	73.98	-43.42
12205.00	-135.00	Avg	H	68.23	0.00	40.23	53.98	-13.75
12205.00	-125.00	Peak	H	68.23	0.00	50.23	73.98	-23.75

Table 6-7. Radiated Measurements

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Radiated Spurious Emission Measurements (Cont'd)

§15.205 & §15.209, §15.247 (d); RSS-210 (A8.5)

Worst Case Mode:	Bluetooth
Worst Case Data Rate:	3Mbps
Measurement Distance:	3 Meters
Operating Frequency:	2480MHz
Channel:	78

Frequency [MHz]	Analyzer Level [dBm]	Detector	Pol [H/V]	AFCL [dB]	Duty Cycle Correction [dB]	Field Strength [dBµV/m]	Limit [dBµV/m]	Margin [dB]
4960.00	-97.02	Avg	H	42.17	-22.50	29.66	53.98	-24.32
4960.00	-108.68	Peak	H	42.17	0.00	40.50	73.98	-33.48
7440.00	-135.00	Avg	H	48.61	0.00	20.61	53.98	-33.37
7440.00	-125.00	Peak	H	48.61	0.00	30.61	73.98	-43.37
12400.00	-135.00	Avg	H	71.03	0.00	43.03	53.98	-10.95
12400.00	-125.00	Peak	H	71.03	0.00	53.03	73.98	-20.95

Table 6-8. Radiated Measurements

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6.10 Radiated Restricted Band Edge Measurements

§15.205 & §15.209, §15.247 (d); RSS-210 (A8.5)

Worst Case Mode:	Bluetooth
Worst Case Data Rate:	3Mbps
Measurement Distance:	3 Meters
Operating Frequency:	2480MHz
Channel:	78

Frequency [MHz]	Analyzer Level [dBm]	Detector	Pol [H/V]	AFCL [dB]	Duty Cycle Correction [dB]	Field Strength [dBµV/m]	Limit [dBµV/m]	Margin [dB]
2483.50	-108.10	Avg	H	35.93	-22.50	12.33	53.98	-41.65
2483.50	-93.32	Peak	H	35.93	0.00	49.61	73.98	-24.37
2484.29	-108.70	Avg	H	35.94	-22.50	11.74	53.98	-42.24
2484.29	-95.87	Peak	H	35.94	0.00	47.07	73.98	-26.91
2491.72	-108.52	Avg	H	36.00	-22.50	11.98	53.98	-42.00
2491.72	-95.08	Peak	H	36.00	0.00	47.92	73.98	-26.06

Table 6-9. Radiated Restricted Band Edge Measurements at 3-meters

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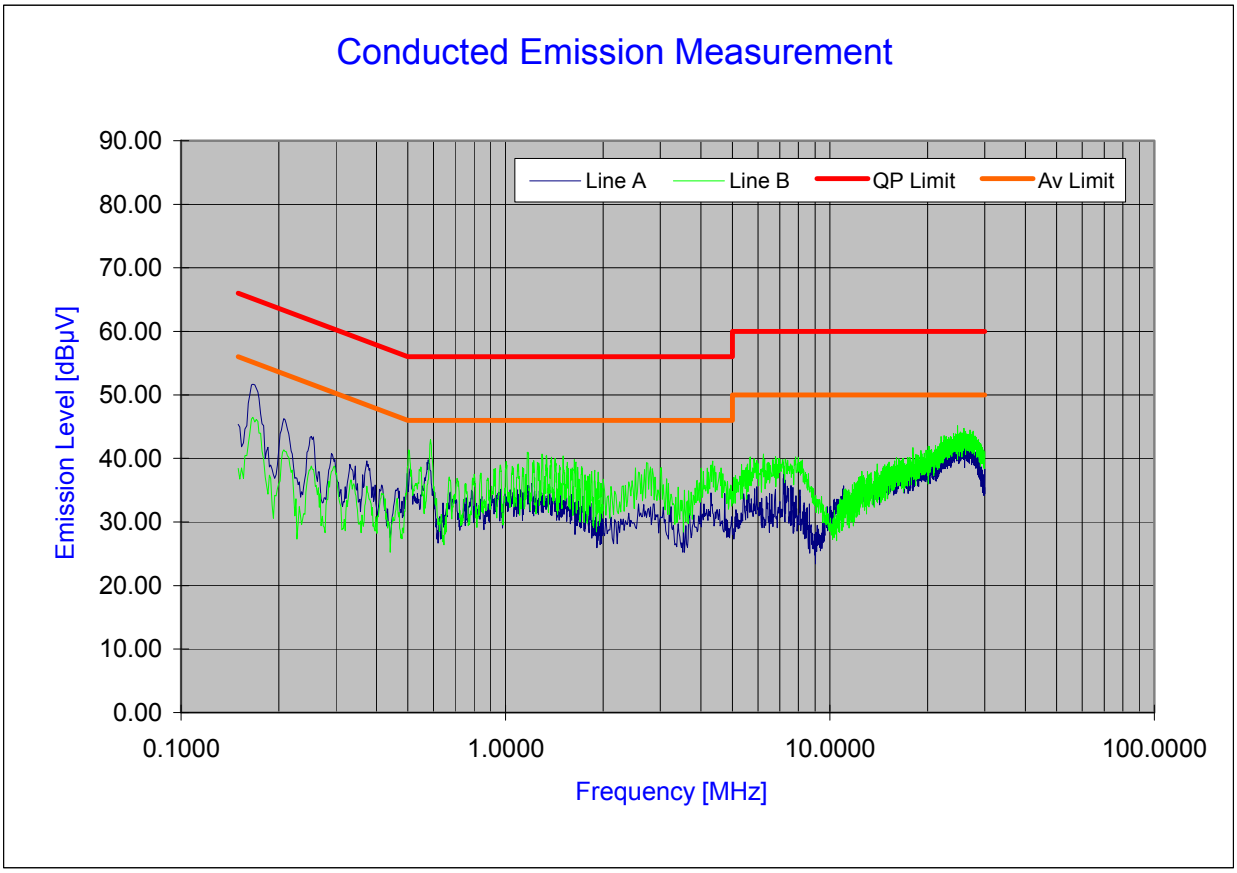
6.11 Line-Conducted Test Data

§15.207; RSS-Gen (7.2.2)

PCTEST Engineering Laboratory Inc.

Company : Samsung Electronics, Co. Ltd.
Model Number : SM-W750V
FCC ID Code : A3LSMW750V
Standard : FCC Part 15C, 15.207

Power Source : AC120V/60Hz
Tested Date : 12/23/2013
Note : Tested with Bluetooth ON



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Plot 6-42. Line Conducted Plot with Bluetooth

Notes:

1. All modes of operation, data rates, and test channels were investigated and the worst-case emissions are reported in BT BDR mode using 1Mbps on Channel 39. The emissions found were not affected by the choice of channel used during testing.
2. The limit for intentional radiators from 150kHz to 30MHz are specified in Section 15.207 of the Title 47 CFR.
3. Line A = Phase; Line B = Neutral
4. Traces shown in plot are made using a peak detector.
5. Deviations to the Specifications: None.

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Line-Conducted Test Data (Cont'd)

§15.207; RSS-Gen (7.2.2)

No.	Line	Frequency [MHz]	Factor [dB]	QP [dBµV]	Limit [dBµV]	Margin [dB]	Average [dBµV]	Limit [dBµV]	Margin [dB]
1	A	0.167	6.86	43.07	65.11	-22.04	32.16	55.11	-22.95
2	A	0.195	6.87	39.23	63.84	-24.61	25.86	53.84	-27.98
3	A	0.508	6.97	31.74	56.00	-24.26	24.87	46.00	-21.13
4	A	0.571	6.98	36.67	56.00	-19.33	27.00	46.00	-19.00
5	A	18.321	7.95	42.42	60.00	-17.58	33.78	50.00	-16.22
6	A	24.595	9.02	36.72	60.00	-23.28	28.74	50.00	-21.26
7	A	25.409	9.11	36.61	60.00	-23.39	29.19	50.00	-20.81
8	A	25.962	9.16	36.82	60.00	-23.18	29.07	50.00	-20.93
9	A	26.955	9.26	36.21	60.00	-23.79	28.86	50.00	-21.14
10	A	27.872	9.35	36.00	60.00	-24.00	28.45	50.00	-21.55
11	B	0.511	6.97	37.05	56.00	-18.95	26.80	46.00	-19.20
12	B	0.594	6.99	39.56	56.00	-16.44	28.08	46.00	-17.92
13	B	1.190	7.07	36.35	56.00	-19.65	27.41	46.00	-18.59
14	B	1.304	7.08	35.84	56.00	-20.16	26.53	46.00	-19.47
15	B	1.340	7.09	35.08	56.00	-20.92	27.23	46.00	-18.77
16	B	1.515	7.11	36.18	56.00	-19.82	26.69	46.00	-19.31
17	B	24.697	9.18	39.18	60.00	-20.82	31.42	50.00	-18.58
18	B	25.818	9.31	39.83	60.00	-20.17	31.69	50.00	-18.31
19	B	26.993	9.44	39.62	60.00	-20.38	31.55	50.00	-18.45
20	B	27.727	9.52	39.28	60.00	-20.72	31.44	50.00	-18.56

Table 6-10. Line Conducted Data with Bluetooth

Notes:

1. All modes of operation, data rates, and test channels were investigated and the worst-case emissions are reported in BT BDR mode using 1Mbps on Channel 39. The emissions found were not affected by the choice of channel used during testing.
2. The limit for intentional radiators from 150kHz to 30MHz are specified in Section 15.207 of the Title 47 CFR.
3. Line A = Phase; Line B = Neutral
4. Factor (dB) = Cable loss (dB) + LISN insertion factor (dB)
5. QP/AV Level (dBµV) = QP/AV Analyzer/Receiver Level (dBµV) + Factor (dB)
6. Margin (dB) = QP/AV Level (dBµV) – Limit (dBµV)
7. Traces shown in plot are made using a peak detector.
8. Deviations to the Specifications: None.

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7.0 CONCLUSION

The data collected relate only to the item(s) tested and show that the **Samsung Portable Handset FCC ID: A3LSMW750V** is in compliance with Part 15 Subpart C (15.247) of the FCC Rules.

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